



ANSI C63.19 TEST REPORT

Product Name	HSDPA/UMTS dual band / GSM quad bands mobile		
	phone		
Model Name	Tequila US1 plus		
Marketing Name	one touch 910A		
FCC ID	RAD215		
Client	TCT Mobile Limited		

TA Technology (Shanghai) Co., Ltd.

TA Technology (Shanghai) Co.,	Ltd.
Test Report	

Report No. RZA1109-1552HAC01

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GENERAL SUMMARY

Product Name	HSDPA/UMTS dual band / GSM quad bands mobile phone	Model	Tequila US1 plus
Report No.	RZA1109-1552HAC01	FCC ID	RAD215
Client	TCT Mobile Limited		
Manufacturer	TCT Mobile Limited		
Reference Standard(s)	ANSI C63.19-2007: American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.		
Conclusion	This portable wireless equipment has been measured in all cases requested by the relevant standards. General Judgment: M3 (RF Emission) (Stamp) Date of issue: September 11 th , 2011		
Comment	The test result only responds to the	measured sample.	
Approved by Direc	tor Revised by 凌欲		沈辰 med by SAR Engineer

TA Technology	(Shanghai)	Со.,	Ltd.
Tes	st Report		

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1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone dose not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electrical report is inconsistent with the printed one, it should be subject to the latter.

1.2. Testing Laboratory

Company:	TA Technology (Shanghai) Co., Ltd.	
Address:	No.145, Jintang Rd, Tangzhen Industry Park, Pudong Shanghai, China	
City:	Shanghai	
Post code:	201201	
Country:	P. R. China	
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Telephone:	+86-021-50791141/2/3	
Fax:	+86-021-50791141/2/3-8000	
Website:	http://www.ta-shanghai.com	
E-mail:	yangweizhong@ta-shanghai.com	

Report No. RZA1109-1552HAC01

1.3. Applicant Information

Company:	TCT Mobile Limited
Address:	5F, E building, No. 232, Liang Jing Road ZhangJiang High-Tech Park, Pudong Area Shanghai, P.R. China. 201203
City:	Shanghai
Postal Code:	201203
Country:	P.R. China
Contact:	Gong Zhizhou
Telephone:	0086-21-6146089
Fax:	0086-21-61460602

1.4. Manufacturer Information

Company:	TCT Mobile Limited
Address:	5F, E building, No. 232, Liang Jing Road ZhangJiang High-Tech Park, Pudong Area Shanghai, P.R. China. 201203
City:	Shanghai
Postal Code:	201203
Country:	P.R. China
Telephone:	0086-21-6146089
Fax:	0086-21-61460602

1.5. Information of EUT

General Information

Product Name:HSDPA/UMTS dual band / GSM quad bands mobile phoneBrand:ALCATELIMEI:01291100000988Hardware Version:V94Antenna Type:Internal AntennaDevice Operating Configurations:GSM 850/ GSM 1900; (tested)Supporting Mode(s):GSM 850/ GSM 1900; (tested)WCDMA Band II/WCDMA Band V; (tested)Buletooth; (untested)Buletooth; (untested)Buletooth; (untested)Test Modulation:(GSM)GMSK; (WCDMA) QPSKDevice Class:BHSDPA UE Category:8GPRS Multislot Class(12):Max Number of Timeslots in UplinkMax Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 8501850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band II1852.4 ~ 1907.6871.4 ~ 891.6Test Channel:(GSM 850', 4, tested with power level 55GSM 1900: 1, tested with power level 0WCDMA Band II)(tested)4132 - 4183 - 4233(WCDMA Band II)(tested)	Device Type:	Portable Device		
IMEI:01291100000988Hardware Version:PIOSoftware Version:V944Antenna Type:Internal AntennaDevice Operating Configurations:Internal AntennaSupporting Mode(s):GSM 850/ GSM 1900; (tested) WCDMA Band II/WCDMA Band V; (tested)Supporting Mode(s):GSM 900/GSM 1800; (untested) WFI (802.11b/g/n); (untested)Test Modulation:(GSM)GMSK; (WCDMA) QPSKDevice Class:BHSDPA UE Category:8GPRS Multislot Class(12):Max Number of Timeslots in UplinkMax Number of Timeslots in Uplink4Max Total Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Total Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Total Timeslots in Downlink4Max Total Timeslots in Uplink4Max Total Timeslot5Max Rumber of Timeslots in Uplink4Max Total Timeslots in Uplink4Max Total Timeslot5Max Rumber of Timeslots in Uplink4Max Total Timeslot5Max Rumber of Timeslots in Uplink4Max Total Timeslot5Max Total Timeslot5Max Rumb		HSDPA/UMTS dual ba	nd / GSM quad bands m	nobile phone
Hardware Version:PIOSoftware Version:V944Antenna Type:Internal AntennaDevice Operating Configurations:GSM 850/ GSM 1900; (tested)Supporting Mode(s):GSM 850/ GSM 1900; (tested)Supporting Mode(s):GSM 850/ GSM 1900; (untested)Bluetooth; (untested)GSM 900/GSM 1800; (untested)Bluetooth; (untested)Bluetooth; (untested)Test Modulation:(GSM)GMSK; (WCDMA) QPSKDevice Class:BHSDPA UE Category:8Max Number of Timeslots in Uplink4Max Total Timeslots in Downlink4Max Total Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Total Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 983.8Operating Frequency Range(s):GSM 19001850.2 ~ 190.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:GSM 850: 4, tested with power level 5(Low - Middle - High)262.9	Brand:			
Software Version: V944 Antenna Type: Internal Antenna Device Operating Configurations: GSM 850/ GSM 1900; (tested) Supporting Mode(s): GSM 850/ GSM 1900; (tested) WCDMA Band II/WCDMA Band V; (tested) GSM 900/GSM1800; (untested) WiFi (802.11b/g/n); (untested) Bluetooth; (untested) Bluetooth; (untested) GSM 900/GSM1800; (wrested) Device Class: B HSDPA UE Category: 8 GPRS Multislot Class(12): Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Uplink 4	IMEI:	012911000000988		
Antenna Type:Internal AntennaDevice Operating Configurations:GSM 850/ GSM 1900; (tested)Supporting Mode(s):GSM 850/ GSM 1900; (tested)WiFi (802.11b/g/n); (untested)WiFi (802.11b/g/n); (untested)Bluetooth; (untested)Bluetooth; (untested)Device Class:BHSDPA UE Category:8GPRS Multislot Class(12):Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Number of Timeslots in Downlink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Number of Timeslots in Obvin link4Max Number of Timeslots in Downlink4Max Number of Timeslots in Downlink4Max Otal Timeslot5ModeTx (MHz)Rx (MHz)ReferenceGSM 850824.2 ~ 848.8BelletochGSM 850824.2 ~ 848.6BelletochGSM 850824.2 ~ 848.6	Hardware Version:	PIO		
Device Operating Configurations: GSM 850/ GSM 1900; (tested) Supporting Mode(s): GSM 850/ GSM 1900; (tested) WCDMA Band II/WCDMA Band V; (tested) GSM900/GSM1800; (untested) Bluetooth; (untested) Bluetooth; (untested) Bluetooth; (untested) Bluetooth; (untested) Device Class: B MSDPA UE Category: 8 GPRS Multislot Class(12): Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Uplink 1 <td>Software Version:</td> <td>V944</td> <td></td> <td></td>	Software Version:	V944		
Supporting Mode(s): GSM 850/ GSM 1900; (tested) WCDMA Band II/WCDMA Band V; (tested) GSM900/GSM1800; (untested) WiFi (802.11b/g/n); (untested) Bluetooth; (untested) Bluetooth; (untested) Bluetooth; (untested) Device Class: B MSDPA UE Category: 8 GPRS Multislot Class(12): Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Uplink 1	Antenna Type:	Internal Antenna		
WCDMA Band II/WCDMA Band V; (tested)GSM900/GSM1800; (untested)WiFi (802.11b/g/n); (untested)Bluetooth; (untested)Bluetooth; (untested)Device Class:BHSDPA UE Category:8GPRS Multislot Class(12):Max Number of Timeslots in Uplink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Total Timeslot5Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 850824.2 ~ 848.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:(SM 1900)(tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)9262 - 9400 - 9538(WCDMA Band II)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)9262 - 9400 - 9538(WCDMA Band V)(tested)9262 - 9400 - 9538(WCDMA Band V)(tested)9262 - 9400 - 9538(WCDMA Band V)(tes	Device Operating Configurations:			
WCDMA Band II/WCDMA Band V; (tested)GSM900/GSM1800; (untested)WiFi (802.11b/g/n); (untested)Bluetooth; (untested)Bluetooth; (untested)Device Class:BHSDPA UE Category:8GPRS Multislot Class(12):Max Number of Timeslots in Uplink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Total Timeslot5Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 850824.2 ~ 848.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:(SM 1900)(tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)9262 - 9400 - 9538(WCDMA Band II)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)9262 - 9400 - 9538(WCDMA Band V)(tested)9262 - 9400 - 9538(WCDMA Band V)(tested)9262 - 9400 - 9538(WCDMA Band V)(tes		GSM 850/ GSM 1900;	(tested)	
WiFi (802.11b/g/n); (untested) Bluetooth; (untested) Test Modulation: (GSM)GMSK; (WCDMA) QPSK Device Class: B HSDPA UE Category: 8 GPRS Multislot Class(12): Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Uplink 4 Mode Tx (MHz) Rx (MHz) GSM 850 <td></td> <td></td> <td></td> <td></td>				
Bluetooth; (untested) Test Modulation: (GSM)GMSK; (WCDMA) QPSK Device Class: B HSDPA UE Category: 8 GPRS Multislot Class(12): Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Uplink 4 Max Total Timeslot 5 Max Total Timeslot 5 Mode Tx (MHz) Rx (MHz) GSM 850 824.2 ~ 848.8 869.2 ~ 893.8 Operating Frequency Range(s): GSM 1900 1850.2 ~ 1909.8 1930.2 ~ 1989.8 WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 1932.4 ~ 1987.6 WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 128-190-251 (GSM 850) (tested) Test Channel: 128-190-251	Supporting Mode(s):	GSM900/GSM1800; (u	ntested)	
Test Modulation: (GSM)GMSK; (WCDMA) QPSK Device Class: B HSDPA UE Category: 8 GPRS Multislot Class(12): Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Uplink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Downlink 4 Max Number of Timeslots in Downlink 4 Max Total Timeslot 5 Max Total Timeslot 5 Mode Tx (MHz) Rx (MHz) GSM 850 824.2 ~ 848.8 869.2 ~ 893.8 Operating Frequency Range(s): GSM 1900 1850.2 ~ 1909.8 1930.2 ~ 1989.8 WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 1932.4 ~ 1987.6 Test Channel: (Low - Middle - High) 262 - 9400 - 9538 <		WiFi (802.11b/g/n); (un	tested)	
Device Class:BHSDPA UE Category:8MSDPA UE Category:8GPRS Multislot Class(12):Max Number of Timeslots in Uplink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:(GSM 1900 - 9538 (WCDMA Band II)(tested)(Low - Middle - High)9262 - 9400 - 9538 (WCDMA Band II)(tested)9262 - 9400 - 9538 (WCDMA Band V)(tested)4132 - 4183 - 4233 (WCDMA Band V)(tested)Power Class:GSM 1900: 1, tested with power level 5GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits		Bluetooth; (untested)		
HSDPA UE Category:8Max Number of Timeslots in Uplink4GPRS Multislot Class(12):Max Number of Timeslots in Downlink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4EGPRS Multislot Class(12):Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:(I28-190-251(GSM 850)(tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)(tested)9262 - 9400 - 9538(WCDMA Band II)(tested)4132 - 4183 - 4233(WCDMA Band V)Power Class:GSM 850: 4, tested with power level 5GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits	Test Modulation:	(GSM)GMSK; (WCDM	A) QPSK	
Max Number of Timeslots in Uplink4GPRS Multislot Class(12):Max Number of Timeslots in Downlink4Max Total Timeslot5Max Number of Timeslots in Uplink4Max Number of Timeslots in Uplink4EGPRS Multislot Class(12):Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:(I28-190-251(GSM 850)(tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)(tested)9262 - 9400 - 9538(WCDMA Band V)(tested)4132 - 4183 - 4233(WCDMA Band V)Power Class:GSM 850: 4, tested with power level 5GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits	Device Class:	В	-	
GPRS Multislot Class(12):Max Number of Timeslots in Downlink4Max Total Timeslot5Max Number of Timeslots in Uplink4EGPRS Multislot Class(12):Max Number of Timeslots in Downlink4Max Total Timeslot5Max Total Timeslot5Max Total Timeslot5ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8Operating Frequency Range(s):GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:512-661-810(GSM 850) (tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)9262 - 9400 - 9538(WCDMA Band V)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)Power Class:GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control I up bits	HSDPA UE Category:			
Max Total Timeslot5EGPRS Multislot Class(12):Max Number of Timeslots in Uplink4Max Number of Timeslots in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:128-190-251(GSM 850)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)9262 - 9400 - 9538(WCDMA Band V)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)Power Class:GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits		Max Number of Timeslots in Uplink		4
BigsMax Number of TimesIots in Uplink4EGPRS Multislot Class(12):Max Number of TimesIots in Downlink4Max Total TimesIot5ModeTx (MHz)Rx (MHz)ModeTx (MHz)Rx (MHz)GSM 850824.2 ~ 848.8869.2 ~ 893.8GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:128-190-251(GSM 850)(Low - Middle - High)262 - 9400 - 9538(WCDMA Band II)Power Class:GSM 850: 4, tested with power level 5Power Class:GSM 1900: 1, tested with power level 0	GPRS Multislot Class(12):	Max Number of Timeslots in Downlink		4
EGPRS Multislot Class(12):Max Number of Times/s in Downlink4Max Total Timeslot5ModeTx (MHz)Rx (MHz)Operating Frequency Range(s):GSM 850824.2 ~ 848.8869.2 ~ 893.8GSM 19001850.2 ~ 1909.81930.2 ~ 1989.8WCDMA Band II1852.4 ~ 1907.61932.4 ~ 1987.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6WCDMA Band V826.4 ~ 846.6871.4 ~ 891.6Test Channel:128-190-251(GSM 850) (tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)(tested)9262 - 9400 - 9538(WCDMA Band V)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)Power Class:GSM 850: 4, tested with power level 5GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits		Max Total Timeslot		5
Max Total Timeslot 5 Mode Tx (MHz) Rx (MHz) Operating Frequency Range(s): GSM 850 824.2 ~ 848.8 869.2 ~ 893.8 GSM 1900 1850.2 ~ 1909.8 1930.2 ~ 1989.8 1930.2 ~ 1989.8 WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 Test Channel: (I28-190-251) (GSM 850) (tested) (Low - Middle - High) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) (tested) Power Class: GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits		Max Number of Times	ots in Uplink	4
Mode Tx (MHz) Rx (MHz) Operating Frequency Range(s): GSM 850 824.2 ~ 848.8 869.2 ~ 893.8 Operating Frequency Range(s): GSM 1900 1850.2 ~ 1909.8 1930.2 ~ 1989.8 WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 Test Channel: 128-190-251 (GSM 850) (tested) (Low - Middle - High) 512-661-810 (GSM 1900) (tested) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) Fower Class: GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0	EGPRS Multislot Class(12):	Max Number of Timeslots in Downlink		4
Operating Frequency Range(s): GSM 850 824.2 ~ 848.8 869.2 ~ 893.8 GSM 1900 1850.2 ~ 1909.8 1930.2 ~ 1989.8 WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 Test Channel: 128-190-251 (GSM 850) (tested) (Low - Middle - High) 512-661-810 (GSM 1900) (tested) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 5 GSM 1900: 1, tested with power control all up bits		Max Total Timeslot		5
Operating Frequency Range(s): GSM 1900 1850.2 ~ 1909.8 1930.2 ~ 1989.8 WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 Test Channel: 128-190-251 (GSM 850) (tested) (Low - Middle - High) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 9262 - 9400 - 9538 (WCDMA Band V) (tested) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) (tested) Power Class: GSM 1900: 1, tested with power level 5 GSM 1900: 1, tested with power control all up bits		Mode	Tx (MHz)	Rx (MHz)
WCDMA Band II 1852.4 ~ 1907.6 1932.4 ~ 1987.6 WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 Test Channel: 128-190-251 (GSM 850) (tested) (Low - Middle - High) 512-661-810 (GSM 1900) (tested) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits		GSM 850	824.2 ~ 848.8	869.2 ~ 893.8
WCDMA Band V 826.4 ~ 846.6 871.4 ~ 891.6 Test Channel: 128-190-251 (GSM 850) (tested) (Low - Middle - High) 512-661-810 (GSM 1900) (tested) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) 6SM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits WCDMA Band II: 3, tested with power control all up bits	Operating Frequency Range(s):	GSM 1900	1850.2 ~ 1909.8	1930.2 ~ 1989.8
Test Channel: 128-190-251 (GSM 850) (tested) (Low - Middle - High) 512-661-810 (GSM 1900) (tested) 9262 - 9400 - 9538 (WCDMA Band II) (tested) 4132 - 4183 - 4233 (WCDMA Band V) (tested) GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits		WCDMA Band II	1852.4 ~ 1907.6	1932.4 ~ 1987.6
Test Channel:512-661-810(GSM 1900)(tested)(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)GSM 850: 4, tested with power level 5GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits		WCDMA Band V	826.4 ~ 846.6	871.4 ~ 891.6
(Low - Middle - High)9262 - 9400 - 9538(WCDMA Band II)(tested)4132 - 4183 - 4233(WCDMA Band V)(tested)GSM 850: 4, tested with power level 5GSM 1900: 1, tested with power level 0WCDMA Band II: 3, tested with power control all up bits		128-190-251 (G	SM 850) (tested)	
4132 - 4183 - 4233 (WCDMA Band V) (tested) GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits	Test Channel:	512-661-810 (G	SM 1900) (tested)	
GSM 850: 4, tested with power level 5 GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits	(Low - Middle - High)	9262 - 9400 - 9538	(WCDMA Band II)	(tested)
Power Class: GSM 1900: 1, tested with power level 0 WCDMA Band II: 3, tested with power control all up bits		4132 - 4183 - 4233	(WCDMA Band V)	(tested)
Power Class: WCDMA Band II: 3, tested with power control all up bits		GSM 850: 4, tested with power level 5		
WCDMA Band II: 3, tested with power control all up bits	Power Class:	GSM 1900: 1, tested with power level 0		
	rower Class.	WCDMA Band II: 3, tested with power control all up bits		
WCDMA Band V: 3, tested with power control all up bits		WCDMA Band V: 3, tested with power control all up bits		

Auxiliary Equipment Details

AE:Battery			
Model:	1		
Manufacturer:	BYD		
S/N:	CAB31P0000C1		

Equipment Under Test (EUT) is a model of HSDPA/UMTS dual band / GSM quad bands mobile phone. The detail about Mobile phone and Lithium Battery is in chapter 1.5 in this report. HAC is tested for GSM 850, GSM 1900, WCDMA Band II and WCDMA Band V. The device has an internal antenna for GSM/WCDMA Tx/Rx, and the other is BT/WIFI antenna that is used for Tx/Rx. WiFi and Bluetooth modes don't have voice capability, and do not operate in the held to ear mode for providing handset service.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

1.6. The Ambient Conditions during Test

Temperature	Min. = 18°C, Max. = 28 °C	
Relative humidity	Min. = 0%, Max. = 80%	
Ground system resistance	< 0.5 Ω	
Ambient noise is checked and found very low and in compliance with requirement of standards.		
Reflection of surrounding objects is minimized and in compliance with requirement of standards.		

1.7. The Total M-rating of each tested band

Mode	Rating
GSM 850	М3
GSM 1900	М3
WCDMA Band II	M4
WCDMA Band V	M4

1.8. Test Date

The test is performed from September 13, 2011 to September 14, 2011.

2. Test Information

2.1. Operational Conditions during Test

2.1.1. General Description of Test Procedures

The phone was tested in all normal configurations for the ear use. The EUT is mounted in the device holder equivalent as for classic dosimeter measurements. The acoustic output of the EUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame The EUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete. The EUT holder is on the yellow base plate of the Test Arch phantom. These test configurations are tested at the high, middle and low frequency channels of each applicable operating mode; for example, GSM, WCDMA (UMTS), CDMA and TDMA.

TA Technology (Shanghai) Co., Ltd. Test Report

2.1.2. GSM/WCDMA Test Configuration

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The Absolute Radiofrequency Channel Number (ARFCN) is allocated to 128, 190 and 251 in the case of GSM 850, to 512, 661 and 810 in the case of GSM 1900, to 9262, 9400 and 9538 in the case of WCDMA Band II, to 4132, 4183 and 4233 in the case of WCDMA Band V. The EUT is commanded to operate at maximum transmitting power.Using E5515C the power lever is set to "5" in SAR of GSM 850, set to "0" in SAR of GSM 1900. Set to all "1's" for WCDMA.The test in the band of GSM 850/1900 and WCDMA Band IV are performed in the mode of speech transfer function.

2.2. HAC RF Measurements System Configuration

2.2.1. HAC Measurement Set-up

These measurements are performed using the DASY5 automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. Cell controller systems contain the power supply, robot controller, teach pendant (Joystick) and remote control, and are used to drive the robot motors. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification; signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

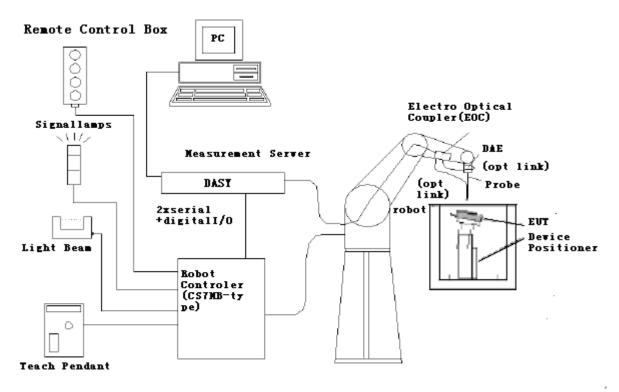


Figure 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

2.2.2. Probe System

The HAC measurements were conducted with the E-Field Probe ER3DV6 and the H-Field Probe H3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

E-Field Probe Description

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material	ITE
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, k=2)	
Frequency	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz)	Figure 2 ER3DV6 E-field Probe
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)	
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB	
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm	
Application	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms	

H-Field Probe Description

Construction	Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)	
Frequency	200 MHz to 3 GHz (absolute accuracy ± 6.0%, k=2); Output linearized	Figure 3 H3DV6 H-field Probe
Directivity	± 0.2 dB (spherical isotropy error)	
Dynamic Range	10 mA/m to 2 A/m at 1 GHz	
E-Field Interference	< 10% at 3 GHz (for plane wave)	
Dimensions	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm	

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Application	General magnetic near-field measurements up to 3
	GHz (in air or liquids)
	Field component measurements
	Surface current measurements
	Low interaction with the measured field

2.2.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Device reference point is set for the EUT at 6.3 mm, the Grid reference point is on the upper surface at the origin of the coordinates, and the "user point \Height Check 0.5 mm" is 0.5mm above the center, allowing verication of the gap of 0.5mm while the probe is positioned there.

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $\leq \pm 0.5$ dB.

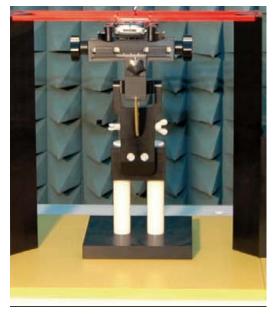


Figure 4 HAC Phantom & Device Holder

2.3. RF Test Procedures

The evaluation was performed with the following procedure:

- 1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2. Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements is at different distances from the tip of the probe.
- 3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4. The center sub-grid shall center on the center of the axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5. Record the reading.
- 6. Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
- 8. Identify the maximum field reading within the non-excluded sub-grids identified in Step 7.
- 9. Convert the maximum field strength reading identified in Step 8 to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
- 10. Repeat Step 1 through Step 10 for both the E-field and H-field measurements.
- 11. Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10 for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

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Figure 5 WD reference and plane for RF emission measurements

2.4. System Check

Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna.

The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions.

The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements. Validation was performed to verify that measured E-field and H-field values are within +/-25% from the target refenence values provided by the manufacturer. "Values within +/-25% are acceptable. Of which 12% is deviation and 13% is measurement uncertainty."

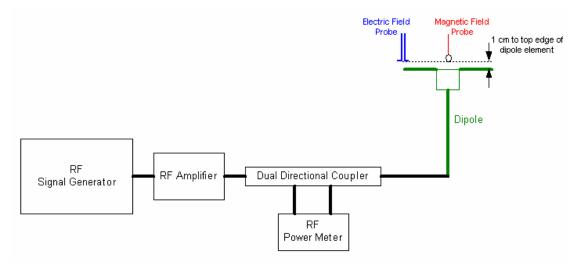


Figure 6 Dipole Validation Setup

Dipole Measurement Summary

	E-Field Scan							
Mode	Frequency (MHz)	Input Power (mW)	Measured ¹ Value(V/m)	Target ² Value(V/m)	Deviation ³ (%)	Test Date		
CW	835	100	149.2	158.2	5.69	September 13, 2011		
CW	1880	100	131.4	142.9	8.05	September 13, 2011		
			H-Field S	Scan				
Mode	Frequency	Input Power	Measured ¹	Target ²	Deviation ³	Test Date		
wode	(MHz)	(mW)	Value(V/m)	Value(V/m)	(%)	Test Date		
CW	835	100	0.443	0.446	0.67	September 14, 2011		
CW	1880	100	0.449	0.475	5.47	September 14, 2011		

Notes: 1. please refer to the attachment for detailed measurement data and plot.

2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.

3. Deviation (%) = 100 * (Target value minus Measured value) divided by Target value.

2.5. Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1).Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

Modulation Factor Test Procedure

This may be done using the following procedure:

- 1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna.
- 2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
- 3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
- 4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
- 6. Record the reading of the probe measurement system of the unmodulated signal.
- The ratio, in linear units, of the probe reading in Step 6 to the reading in Step 3 is the E-field modulation factor. PMF_E = E_{CW} / E_{mod} (PMF_H = H_{CW} / H_{mod})
- 8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

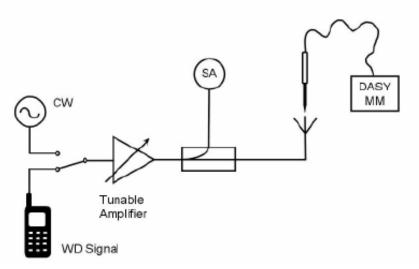


Figure 7 Probe Modulation Factor Test Setup

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Band	E-Field Probe Modulation Factor	H-Field Probe Modulation Factor
GSM 850	2.81	2.75
GSM 1900	2.84	2.84
WCDMA Band II	1.02	1.01
WCDMA Band V	1.03	1.01

2.6. Conducted Output Power Measurement

Summary

The DUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

Conducted Power Results

GSM 850	Conducted Power(dBm)			
GSW 050	Channel 128	Channel 190	Channel 251	
Test Results	32.66	32.45	32.27	
GSM 1900	Co	onducted Power(dBm)		
G3W 1900	Channel 512	Channel 661	Channel 810	
Test Results	28.62 28.82		28.82	
WCDMA Band II	Conducted Power(dBm)			
	Channel 9262	Channel 9400	Channel 9538	
Test Results	21.13 21.55		21.35	
WCDMA Band V	Conducted Power(dBm)			
	Channel 4132	Channel 4183	Channel 4233	
Test Results	21.92	22.38	21.98	

3. Test Results

3.1. ANSI C63.19-2007 Limits

Category		Telephone RF parameters < 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m
	-5	473.2 to 841.4	V/m	1.43 to 2.54	A/m
Category M2/T2	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m
	-5	266.1 to 473.2	V/m	0.80 to 1.43	A/m
Cotogon (M2/T2	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
Category M3/T3	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Cotogon M4/T4	0	< 199.5	V/m	< 0.60	A/m
Category M4/T4	-5	< 149.6	V/m	< 0.45	A/m
Category		Telephone RF parameters > 960 MHz			
Near field	AWF	E-field emis	sions	H-field emissions	
Category M1/T1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Cotogon M2/T2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m
Category M2/T2	-5	84.1 to 149.6	V/m	0.25 to 0.45	A/m
Catagory M2/T2	0	63.1 to 112.2	V/m	0.19 to 0.34	A/m
Category M3/T3	-5	47.3 to 84.1	V/m	0.14 to 0.25	A/m
Cotogon MA/TA	0	< 63.1	V/m	< 0.19	A/m
Category M4/T4	-5	< 47.3	V/m	< 0.14	A/m

3.2. Summary Test Results

GSM 850 Results

	E-Field						
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results		
High/251	848.8	195.0	-0.028	М3	Figure 12		
Middle/190	836.6	202.3	-0.025	M3	Figure 13		
Low/128	824.2	211.1	0.033	M3	Figure 14		
		H-Field	I				
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results		
High/251	848.8	0.273	-0.009	M4	Figure 15		
Middle/190	836.6	0.272	0.033	M4	Figure 16		
Low/128	824.2	0.281	0.010	M4	Figure 17		

GSM 1900 Results

E-Field						
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results	
High/810	1909.8	63.1	-0.000	M3	Figure 18	
Middle/661	1880	68.0	0.026	M3	Figure 19	
Low/512	1850.2	66.3	0.002	M3	Figure 20	
		H-Field	l			
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results	
High/810	1909.8	0.155	0.010	M3	Figure 21	
Middle/661	1880	0.161	-0.027	M3	Figure 22	
Low/512	1850.2	0.173	0.079	M3	Figure 23	

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WCDMA Band II Results

E-Field						
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results	
High/9538	1907.6	31.4	-0.007	M4	Figure 24	
Middle/9400	1880	31.5	-0.043	M4	Figure 25	
Low/9262	1852.4	29.1	-0.016	M4	Figure 26	
		H-Field				
Channel	Channel Frequency (MHz) Peak Field (A/m) Power Drift (dB) Rating					
High/9538	1907.6	0.073	0.090	M4	Figure 27	
Middle/9400	1880	0.071	0.102	M4	Figure 28	
Low/9262	1852.4	0.071	0.031	M4	Figure 29	

WCDMA Band V Results

E-Field						
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results	
High/4233	846.6	65.9	-0.065	M4	Figure 30	
Middle/4183	836.6	69.6	0.007	M4	Figure 31	
Low/4132	826.4	63.7	-0.018	M4	Figure 32	
		H-Field				
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results	
High/4233	846.6	0.093	0.090	M4	Figure 33	
Middle/4183	836.6	0.095	-0.017	M4	Figure 34	
Low/4132	826.4	0.081	0.045	M4	Figure 35	

4. Measurement Uncertainty

No.	Error source	Туре	Uncertainty Value (%)	Prob. Dist.	k	c _{i/} E	c _{i\} H	Standard Uncertainty (%) u'_i (%)	Standard Uncertainty (%) u'_i (%)	Degree of freedom V _{eff} or v _i
								E	Н	
1	Droha Calibratian	В	5.1	Measu N	1	System	1	5.1	5.1	∞
-	Probe Calibration	Б	J. I	IN	1	1	1	5.1	5.1	~
2	Axial Isotropy	В	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
3	Sensor Displacement	В	16.5	R	$\sqrt{3}$	1	0.145	9.5	1.4	∞
4	Boundary Effects	В	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	×
5	Linearity	В	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
6	Scaling to Peak Envelope Power	В	2.0	R	$\sqrt{3}$	1	1	1.2	1.2	∞
7	System Detection Limit	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
8	Readout Electronics	В	0.3	Ν	1	1	1	0.3	0.3	∞
9	Response Time	В	0.8	R	$\sqrt{3}$	1	1	0.5	0.5	∞
10	Integration Time	В	2.6	R	$\sqrt{3}$	1	1	1.5	1.5	×
11	RF Ambient Conditions	В	3.0	R	$\sqrt{3}$	1	1	1.7	1.7	∞
12	RF Reflections	В	12.0	R	$\sqrt{3}$	1	1	6.9	6.9	∞
13	Probe Positioner	В	1.2	R	$\sqrt{3}$	1	0.67	0.7	0.5	œ
14	Probe Positioning	А	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	œ
15	Extra. And Interpolation	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
Test	Sample Related									
16	Device Positioning Vertical	В	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	8
17	Device Positioning Lateral	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	×
18	Device Holder and Phantom	В	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	×

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19	Power Drift	В	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	∞
	Phantom and Setup related									
20s	Phantom Thickness	В	2.4	R	$\sqrt{3}$	1	0.67	1.4	0.9	8
Com	Combined standard uncertainty(%)					14.7	10.9			
Expa	Expanded Std. uncertainty on power (K=2)					29.4	21.8			
Expa	nded Std. uncertainty or	n field (K	=2)					14.7	10.9	

5. Main Test Instruments

No.	Name	Туре	Serial Number	Calibration Date	Valid Period
01	Power meter	Agilent E4417A	GB41291714	March 12, 2011	One year
02	Power sensor	Agilent N8481H	MY50350004	September 26, 2010	One year
03	Signal Generator	HP 8341B	2730A00804	September 12, 2011	One year
04	Amplifier	IXA-020	0401	No Calibration R	equested
05	BTS	E5515C	MY48360988	December 3, 2010	One year
06	E-Field Probe	ER3DV6	2428	October 20, 2009	Two years
07	H-Field Probe	H3DV6	6260	October 20, 2009	Two years
08	DAE	DAE4	871	November 18, 2010	One year
09	Validation Kit 835MHz	CD835V3	1133	April 22, 2009	Three years
10	Validation Kit 1880MHz	CD1880V3	1135	January 13, 2010	Three years

*****END OF REPORT BODY*****

ANNEX A: System Check Results

HAC_System Performance Check at 835MHz_E

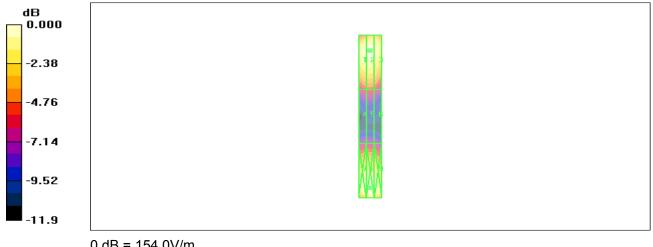
DUT: Dipole 835 MHz; Type: CD835V3; SN:1133 Date/Time: 9/13/2011 1:25:32 PM Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45 E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 149.2 V/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 100.7 V/m; Power Drift = -0.066 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

	-	
Grid 1	Grid 2	Grid 3
147.0 M4	149.2 M4	143.9 M4
Grid 4	Grid 5	Grid 6
83.4 M4	85.0 M4	81.1 M4
Grid 7	Grid 8	Grid 9
148.8 M4	154.0 M4	148.9 M4

Peak E-field in V/m







HAC_System Performance Check at 835MHz_H DUT: Dipole 835 MHz; Type: CD835V3; SN: 1133

Date/Time: 9/14/2011 8:15:58 AM Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.443 A/m

Probe Modulation Factor = 1.00

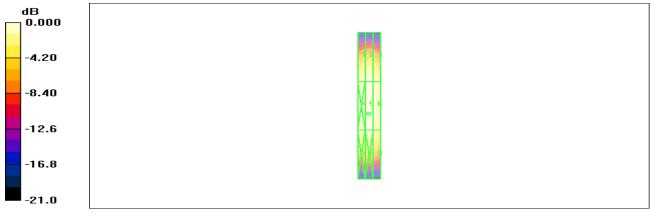
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.464 A/m; Power Drift = 0.019 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
0.391 M4	0.408 M4	0.384 M4
Grid 4	Grid 5	Grid 6
0.427 M4	0.443 M4	0.414 M4
		-
 		Grid 9

Deak H-field in A/m



0 dB = 0.443A/m

HAC_System Performance Check at 1880MHz_E DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1135 Date/Time: 9/13/2011 12:01:34 PM Communication System: CW; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 131.4 V/m

Probe Modulation Factor = 1.00

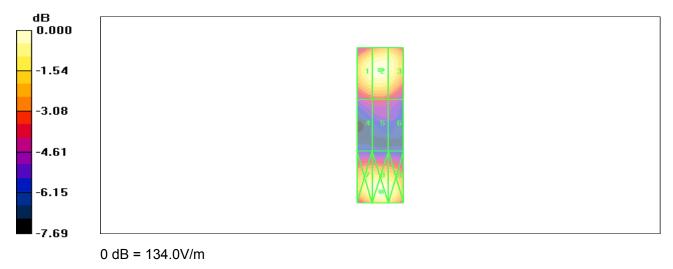
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 151.0 V/m; Power Drift = -0.047 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
128.5 M2	131.4 M2	128.5 M2
Grid 4	Grid 5	Grid 6
87.5 M3	89.7 M3	86.2 M3
Grid 7	Grid 8	Grid 9
128.7 M2	134.0 M2	130.3 M2

Peak E-field in V/m





HAC_System Performance Check at 1880MHz_H

DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1135

Date/Time: 9/14/2011 6:52:22 AM Communication System: CW; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.449 A/m

Probe Modulation Factor = 1.00

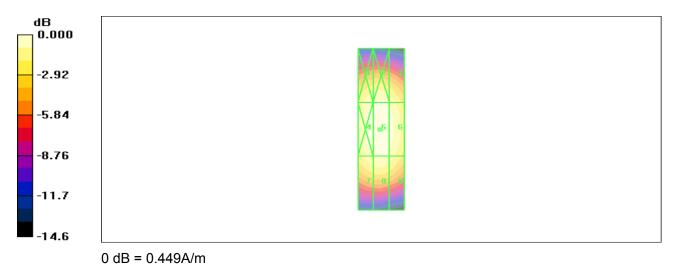
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.472 A/m; Power Drift = -0.005 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

	-	
Grid 1	Grid 2	Grid 3
0.400 M2	0.413 M2	0.387 M2
Grid 4	Grid 5	Grid 6
0.435 M2	0.449 M2	0.422 M2
Grid 7	Grid 8	Grid 9
0.397 M2	0.410 M2	0.384 M2

Peak H-field in A/m





Report No. RZA1109-1552HAC01

ANNEX B: Graph Results

HAC RF E-Field GSM 850 High

Date/Time: 9/13/2011 2:49:54 PM Communication System: GSM850; Frequency: 848.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 195.0 V/m Probe Modulation Factor = 2.81 Device Reference Point: 0, 0, -6.3 mm Reference Value = 92.6 V/m; Power Drift = -0.028 dB Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
177.5 M3	187.1 M3	171.6 M3
Grid 4	Grid 5	Grid 6
185.1 M3	195.0 M3	179.6 M3
Grid 7	Grid 8	Grid 9
182.5 M3	192.9 M3	177.4 M3

Peak E-field in V/m

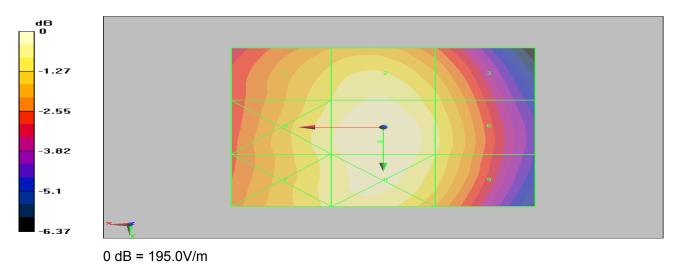


Figure 12 HAC RF E-Field GSM 850 Channel 251

Report No. RZA1109-1552HAC01

HAC RF E-Field GSM 850 Middle

Date/Time: 9/13/2011 2:44:13 PM Communication System: GSM850; Frequency: 836.6 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

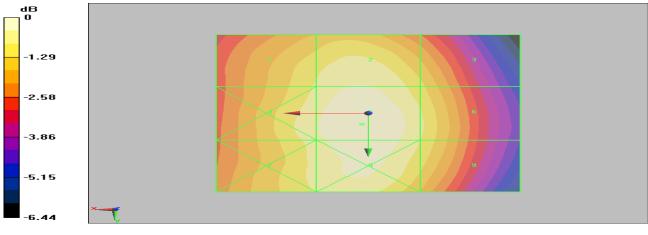
E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Peak E-field in V/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 202.3 V/m Probe Modulation Factor = 2.81 Device Reference Point: 0, 0, -6.3 mm Reference Value = 95.7 V/m; Power Drift = -0.025 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
184.7 M3	193.2 M3	177.3 M3
Grid 4	Grid 5	Grid 6
192.0 M3	202.3 M3	185.4 M3
Grid 7	Grid 8	Grid 9
188.8 M3	199.0 M3	183.7 M3



0 dB = 202.3V/m

Report No. RZA1109-1552HAC01

HAC RF E-Field GSM 850 Low

Date/Time: 9/13/2011 2:56:12 PM Communication System: GSM850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

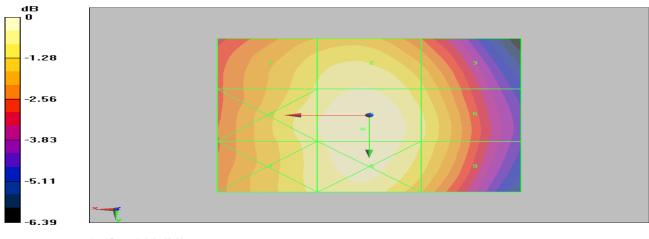
E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 211.1 V/m Probe Modulation Factor = 2.81 Device Reference Point: 0, 0, -6.3 mm Reference Value = 99.4 V/m; Power Drift = 0.033 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
193.1 M3	201.7 M3	185.0 M3
Grid 4	Grid 5	Grid 6
201.1 M3	211.1 M3	194.2 M3
Grid 7	Grid 8	Grid 9
198.4 M3	208.8 M3	192.1 M3

Peak E-field in V/m



 $0 \, dB = 211.1 \, V/m$

Report No. RZA1109-1552HAC01

HAC RF H-Field GSM 850 High

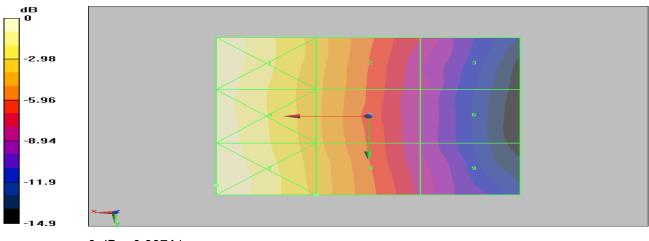
Date/Time: 9/14/2011 9:57:38 AM Communication System: GSM850; Frequency: 848.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.273 A/m Probe Modulation Factor = 2.75 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.073 A/m; Power Drift = -0.009 dB Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
0.390 M4	0.268 M4	0.162 M4
Grid 4	Grid 5	Grid 6
0.380 M4	0.261 M4	0.148 M4
		
Grid 7	Grid 8	Grid 9



0 dB = 0.397A/m

Report No. RZA1109-1552HAC01

HAC RF H-Field GSM 850 Middle

Date/Time: 9/14/2011 9:51:26 AM Communication System: GSM850; Frequency: 836.6 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

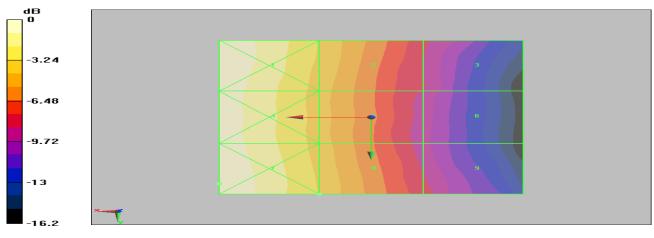
H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.272 A/m Probe Modulation Factor = 2.75 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.072 A/m; Power Drift = 0.033 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
0.397 M4	0.272 M4	0.154 M4
Grid 4	Grid 5	Grid 6
0.382 M4	0.259 M4	0.147 M4
Grid 7	Grid 8	Grid 9
0.398 M4	0.272 M4	0.157 M4



0 dB = 0.398A/m

Report No. RZA1109-1552HAC01

HAC RF H-Field GSM 850 Low

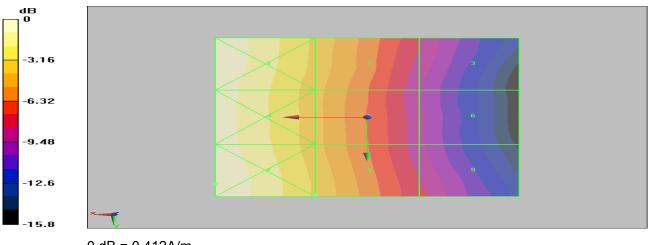
Date/Time: 9/14/2011 10:03:30 AM Communication System: GSM850; Frequency: 824.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.281 A/m Probe Modulation Factor = 2.75 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.074 A/m; Power Drift = 0.010 dB **Hearing Aid Near-Field Category: M4 (AWF -5 dB)**

Grid 1	Grid 2	Grid 3
0.408 M4	0.280 M4	0.159 M4
Grid 4	Grid 5	Grid 6
0.395 M4	0.266 M4	0.145 M4
Grid 7	Grid 8	Grid 9
0.412 M4	0.281 M4	0.165 M4

Peak H-field in A/m



0 dB = 0.412A/m



Report No. RZA1109-1552HAC01

HAC RF E-Field GSM 1900 High

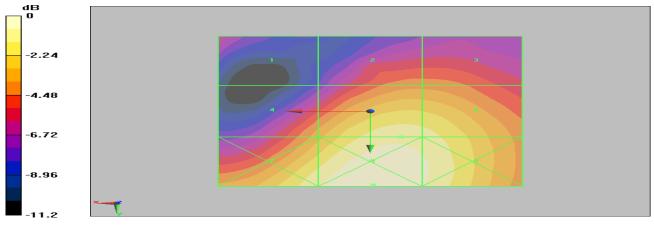
Date/Time: 9/13/2011 3:09:01 PM Communication System: PCS 1900; Frequency: 1909.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 63.1 V/m Probe Modulation Factor = 2.84 Device Reference Point: 0, 0, -6.3 mm Reference Value = 23.8 V/m; Power Drift = -0.000 dB **Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Grid 1	Grid 2	Grid 3	
35.3 M4	44.9 M4	44.8 M4	
Grid 4	Grid 5	Grid 6	
48.7 M3	63.1 M3	62 M3	
Grid 7	Grid 8	Grid 9	
		66.2 M3	

Peak E_field in V/m



0 dB = 70.7V/m

Report No. RZA1109-1552HAC01

HAC RF E-Field GSM 1900 Middle

Date/Time: 9/13/2011 3:01:55 PM Communication System: PCS 1900; Frequency: 1880 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 68 V/m Probe Modulation Factor = 2.84

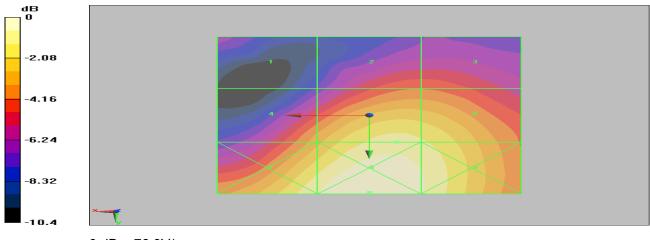
Device Reference Point: 0, 0, -6.3 mm

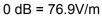
Reference Value = 25.4 V/m; Power Drift = 0.026 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Grid 1	Grid 2	Grid 3	
36.9 M4	47.5 M3	47.5 M3	
Grid 4	Grid 5	Grid 6	
54.6 M3	68 M3	66.4 M3	
Grid 7	Grid 8	Grid 9	
70.9 M3	76.9 M3	71.7 M3	

Peak E-field in V/m







Report No. RZA1109-1552HAC01

HAC RF E-Field GSM 1900 Low

Date/Time: 9/13/2011 3:14:33 PM Communication System: PCS 1900; Frequency: 1850.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 66.3 V/m Probe Modulation Factor = 2.84 Device Reference Point: 0, 0, -6.3 mm Reference Value = 23.6 V/m; Power Drift = 0.002 dB **Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Grid 1	Grid 2	Grid 3	
40.2 M4	42.9 M4	42.9 M4	
Grid 4	Grid 5	Grid 6	
54.5 M3	66.3 M3	64.6 M3	
Grid 7	Grid 8	Grid 9	

Peak E_field in V/m

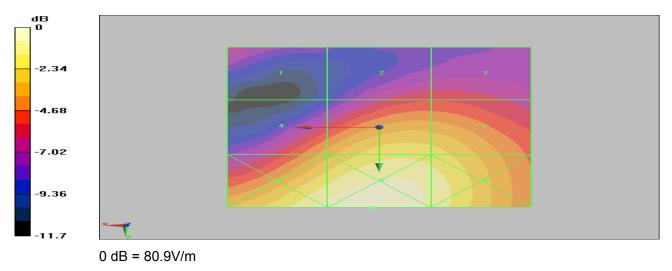


Figure 20 HAC RF E-Field GSM 1900 Channel 512

Report No. RZA1109-1552HAC01

HAC RF H-Field GSM 1900 High

Date/Time: 9/14/2011 9:37:52 AM Communication System: PCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

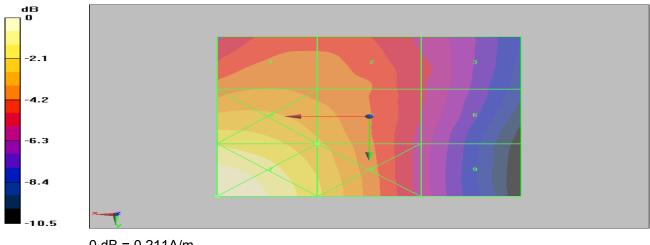
H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.155 A/m Probe Modulation Factor = 2.84 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.049 A/m; Power Drift = 0.010 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
0.142 M3	0.138 M4	0.115 M4
Grid 4	Grid 5	Grid 6
0.178 M3	0.155 M3	0.113 M4
Grid 7	Grid 8	Grid 9
0.211 M3	0.168 M3	0.108 M4



 $0 \, dB = 0.211 \, A/m$

Report No. RZA1109-1552HAC01

HAC RF H-Field GSM 1900 Middle

Date/Time: 9/14/2011 9:31:29 AM Communication System: PCS 1900; Frequency: 1880 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle 2/Hearing Aid

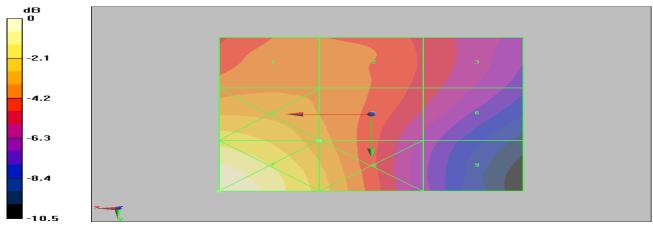
Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.161 A/m Probe Modulation Factor = 2.84 Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.054 A/m; Power Drift = -0.027 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Grid 1	Grid 2	Grid 3
0.155 M3	0.152 M3	0.131 M4
Grid 4	Grid 5	Grid 6
0.193 M3	0.161 M3	0.128 M4
Grid 7	Grid 8	Grid 9
0.233 M3	0.177 M3	0.111 M4



0 dB = 0.233A/m

Report No. RZA1109-1552HAC01

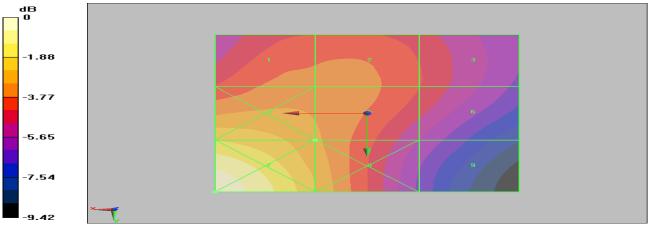
HAC RF H-Field GSM 1900 Low

Date/Time: 9/14/2011 9:43:08 AM Communication System: PCS 1900; Frequency: 1850.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.173 A/m Probe Modulation Factor = 2.84 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.062 A/m; Power Drift = 0.079 dB **Hearing Aid Near-Field Category: M3 (AWF -5 dB)**

Peak H-field in A/m		
Grid 1	Grid 2	Grid 3
0.165 M3	0.165 M3	0.148 M3
Grid 4	Grid 5	Grid 6
0.196 M3	0.173 M3	0.148 M3
Grid 7	Grid 8	Grid 9
0.244 M3	0.184 M3	0.128 M4



0 dB = 0.244 A/m

Report No. RZA1109-1552HAC01

HAC RF E-Field WCDMA Band II High

Date/Time: 9/13/2011 3:32:50 PM Communication System: WCDMA Band II; Frequency: 1907.6 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 31.4 V/m Probe Modulation Factor = 1.02 Device Reference Point: 0, 0, -6.3 mm Reference Value = 31.7 V/m; Power Drift = -0.007 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Grid 1	Grid 2	Grid 3	
19.6 M4	21.9 M4	21.9 M4	
Grid 4	Grid 5	Grid 6	
24 A MA	31.4 M4	24 MA	
24.4 1014	51.4 104	31 WI4	
Grid 7	Grid 8	Grid 9	

Peak E_field in V/m

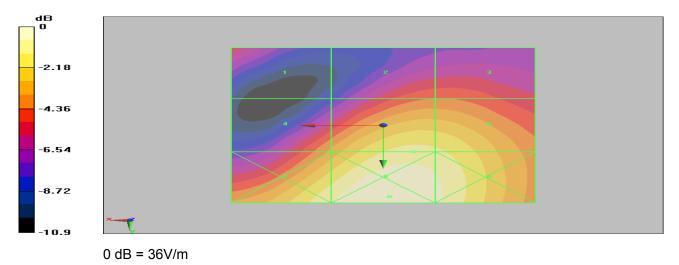


Figure 24 HAC RF E-Field WCDMA Band II Channel 9538

Report No. RZA1109-1552HAC01

HAC RF E-Field WCDMA Band II Middle

Date/Time: 9/13/2011 3:27:18 PM Communication System: WCDMA Band II; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 31.5 V/m Probe Modulation Factor = 1.02

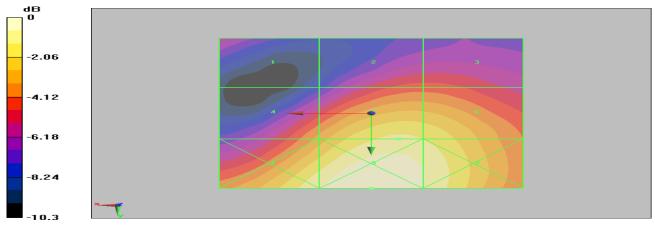
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 32.3 V/m; Power Drift = -0.043 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
18.5 M4	21.8 M4	21.7 M4
Grid 4	Grid 5	Grid 6
25.3 M4	31.5 M4	30.9 M4
Grid 7	Grid 8	Grid 9
		33.6 M4

Peak E-field in V/m







Report No. RZA1109-1552HAC01

HAC RF E-Field WCDMA Band II Low

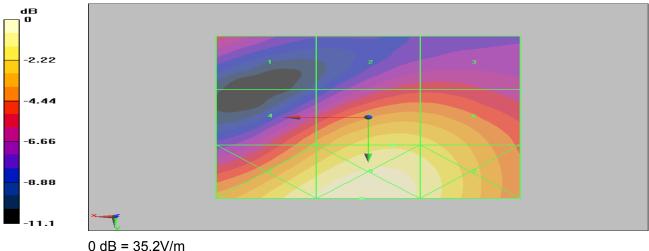
Date/Time: 9/13/2011 3:38:13 PM Communication System: WCDMA Band II; Frequency: 1852.4 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 29.1 V/m Probe Modulation Factor = 1.02 Device Reference Point: 0, 0, -6.3 mm Reference Value = 28.4 V/m; Power Drift = -0.016 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
18.6 M4	18.9 M4	19 M4
Grid 4	Grid 5	Grid 6
23.7 M4	29.1 M4	28.4 M4
Grid 7	Grid 8	Grid 9
22.2.14	35.2 M4	22 MA

Peak E_field in V/m





Report No. RZA1109-1552HAC01

HAC RF H-Field WCDMA Band II High

Date/Time: 9/14/2011 10:17:46 AM Communication System: WCDMA Band II; Frequency: 1907.6 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.073 A/m

Probe Modulation Factor = 1.01 Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.067 A/m; Power Drift = 0.090 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
0.068 M4	0.067 M4	0.057 M4
Grid 4	Grid 5	Grid 6
0.084 M4	0.073 M4	0.056 M4
Grid 7	Grid 8	Grid 9
0.100 M4	0.079 M4	0.052 M4

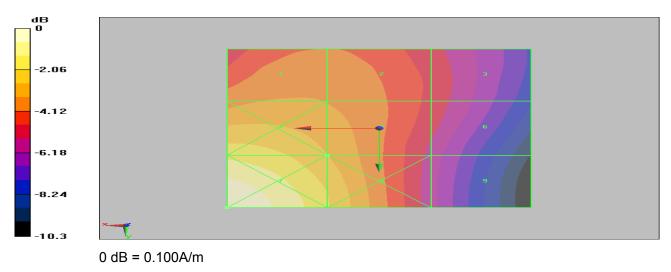


Figure 27 HAC RF H-Field WCDMA Band II Channel 9538

Report No. RZA1109-1552HAC01

HAC RF H-Field WCDMA Band II Middle

Date/Time: 9/14/2011 10:12:11 AM Communication System: WCDMA Band II; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.071 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.067 A/m; Power Drift = 0.102 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
0.068 M4	0.067 M4	0.060 M4
Grid 4	Grid 5	Grid 6
0.085 M4	0.071 M4	0.059 M4
Grid 7	Grid 8	Grid 9
0.102 M4	0.078 M4	0.051 M4

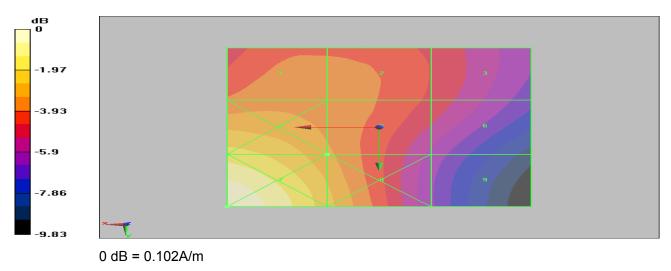


Figure 28 HAC RF H-Field WCDMA Band II Channel 9400

Report No. RZA1109-1552HAC01

HAC RF H-Field WCDMA Band II Low

Date/Time: 9/14/2011 10:24:48 AM Communication System: WCDMA Band II; Frequency: 1852.4 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.071 A/m Probe Modulation Factor = 1.01 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.073 A/m; Power Drift = 0.031 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Grid 1	Grid 2	Grid 3
0.068 M4	0.069 M4	0.063 M4
Grid 4	Grid 5	Grid 6
0.081 M4	0.071 M4	0.062 M4
Grid 7	Grid 8	Grid 9
0 101 M4	0 077 M4	0.054 M4

Deak H-field in A/m

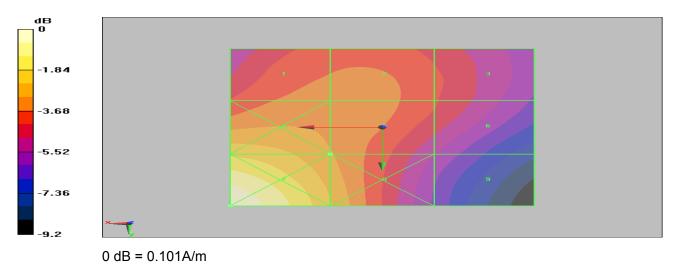


Figure 29 HAC RF H-Field WCDMA Band II Channel 9262

Report No. RZA1109-1552HAC01

HAC RF E-Field WCDMA Band V High

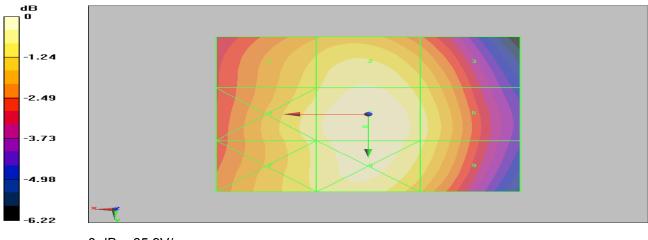
Date/Time: 9/13/2011 3:50:33 PM Communication System: WCDMA Band V; Frequency: 846.6 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 65.9 V/m Probe Modulation Factor = 1.03 Device Reference Point: 0, 0, -6.3 mm Reference Value = 85.6 V/m; Power Drift = -0.065 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

		1
Grid 1	Grid 2	Grid 3
59.5 M4	63.2 M4	58.7 M4
Grid 4	Grid 5	Grid 6
62.1 M4	65.9 M4	61.4 M4
Grid 7	Grid 8	Grid 9
61 3 M4	65 2 M4	60.7 M4

Peak E_field in V/m



0 dB = 65.9V/m

Report No. RZA1109-1552HAC01

HAC RF E-Field WCDMA Band V Middle

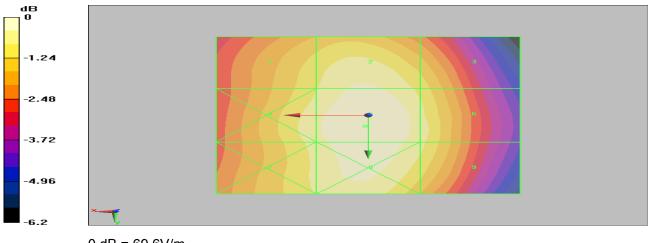
Date/Time: 9/13/2011 3:44:57 PM Communication System: WCDMA Band V; Frequency: 836.6 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 69.6 V/m Probe Modulation Factor = 1.03 Device Reference Point: 0, 0, -6.3 mm Reference Value = 90.3 V/m; Power Drift = 0.007 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Grid 1	Grid 2	Grid 3	
63.2 M4	66.9 M4	62.3 M4	
Grid 4	Grid 5	Grid 6	
65.8 M4	69.6 M4	65.1 M4	
Grid 7	Grid 8	Grid 9	
64.9 M4	68.8 M4	64.3 M4	

Peak E-field in V/m



0 dB = 69.6V/m

Figure 31 HAC RF E-Field WCDMA Band V Channel 4183

Report No. RZA1109-1552HAC01

HAC RF E-Field WCDMA Band V Low

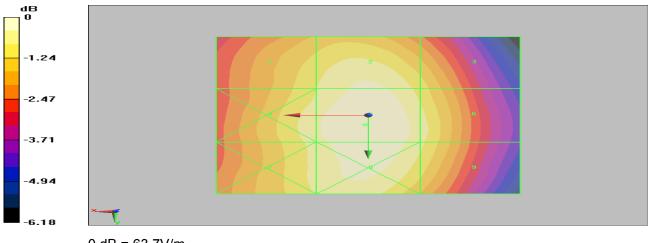
Date/Time: 9/13/2011 3:56:09 PM Communication System: WCDMA Band V; Frequency: 826.4 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 63.7 V/m Probe Modulation Factor = 1.03 Device Reference Point: 0, 0, -6.3 mm Reference Value = 82.5 V/m; Power Drift = -0.018 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Grid 1	Grid 2	Grid 3
58 M4	61.4 M4	56.9 M4
Grid 4	Grid 5	Grid 6
60.3 M4	63.7 M4	59.5 M4
Grid 7	Grid 8	Grid 9
59.4 M4	62.9 M4	58.8 M4

Peak E_field in V/m



0 dB = 63.7V/m



Report No. RZA1109-1552HAC01

HAC RF H-Field WCDMA Band V High

Date/Time: 9/14/2011 10:36:33 AM Communication System: WCDMA Band V; Frequency: 846.6 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Liquid Temperature: 21.5 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

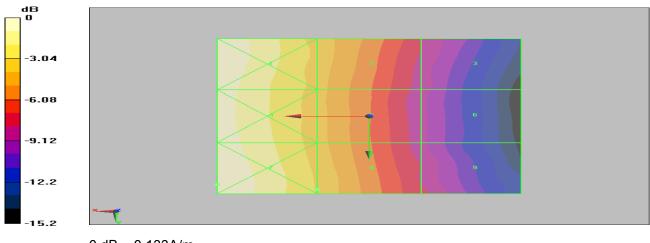
H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.093 A/m Probe Modulation Factor = 1.01 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.067 A/m; Power Drift = 0.090 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

	•	
Grid 1	Grid 2	Grid 3
0.131 M4	0.091 M4	0.053 M4
Grid 4	Grid 5	Grid 6
0.126 M4	0.088 M4	0.050 M4
Grid 7	Grid 8	Grid 9
0.133 M4	0.093 M4	0.055 M4



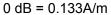


Figure 33 HAC RF H-Field WCDMA Band V Channel 4233

Report No. RZA1109-1552HAC01

HAC RF H-Field WCDMA Band V Middle

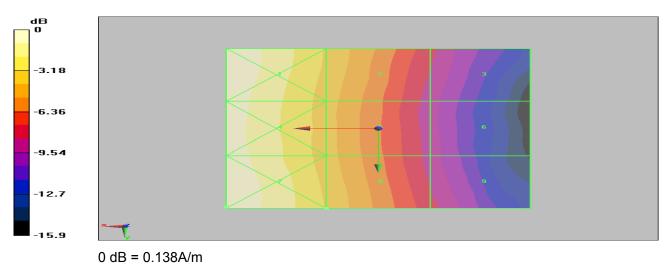
Date/Time: 9/14/2011 10:31:06 AM Communication System: WCDMA Band V; Frequency: 836.6 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Peak H-field in A/m

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.095 A/m Probe Modulation Factor = 1.01 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.068 A/m; Power Drift = -0.017 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
0.137 M4	0.095 M4	0.054 M4
Grid 4	Grid 5	Grid 6
0.131 M4	0.090 M4	0.050 M4
Grid 7	Grid 8	Grid 9
0.138 M4	0.095 M4	0.055 M4



Report No. RZA1109-1552HAC01

HAC RF H-Field WCDMA Band V Low

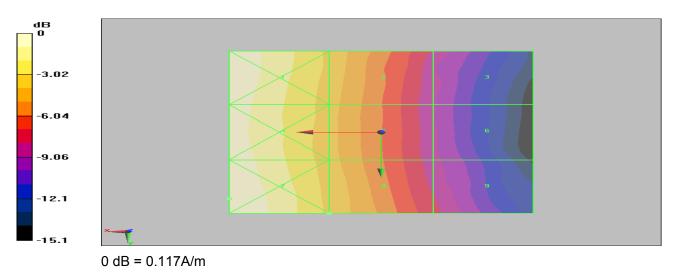
Date/Time: 9/14/2011 10:55:56 AM Communication System: WCDMA Band V; Frequency: 826.4 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY5 Configuration: Probe: H3DV6 - SN6260; Calibrated: 10/20/2009 Electronics: DAE4 Sn871; Calibrated: 11/18/2010 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.081 A/m Probe Modulation Factor = 1.01 Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.059 A/m; Power Drift = 0.045 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Grid 1	Grid 2	Grid 3
0.115 M4	0.080 M4	0.046 M4
Grid 4	Grid 5	Grid 6
0.112 M4	0.078 M4	0.043 M4
Grid 7	Grid 8	Grid 9
0.117 M4	0.081 M4	0.049 M4

Peak H-field in A/m





Report No. RZA1109-1552HAC01

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ANNEX C: E-Probe Calibration Certificate

Schmid & Partner Engineering AG Joughausstrasse 43, 8004 Zurio	ry Of	Hac MRA	Service suisse d'étalonnage Servizio svizzero di taratura
Accredited by the Swiss Accredit The Swiss Accreditation Servic Autiliateral Agreement for the r	e is one of the signatori	es to the EA	n No.: SCS 108
Slient TMC			ic: ER3-2428_Oct09
CALIBRATION	CERTIFICAT	E	
Object	ER3DV6 - SN:2	428	A CONTRACTOR OF
Calibration procedure(s)		and QA CAL-25.v2 edure for E-field probes optimized ir	d for close near field
Calibration date:	October 20, 200	9	And a state of the
The measurements and the unco	ertainties with confidence	tional standards, which realize the physical un probability are given on the following pages ar ory facility: environment temperature (22 ± 3)*	nd are part of the certificate.
The measurements and the unco	ertainties with confidence	probability are given on the following pages ar	nd are part of the certificate.
The measurements and the uno	ertainties with confidence	probability are given on the following pages ar	nd are part of the certificate.
The measurements and the uno All calibrations have been condu Calibration Equipment used (M&	ertainties with confidence inted in the closed laborat TE critical for calibration)	probability are given on the following pages arony facility: environment temperature $(22 \pm 3)^4$	nd are part of the certificate. C and humidity < 70%.
The measurements and the union All calibrations have been condu Calibration Equipment used (M8 Primary Standards	ertainties with confidence acted in the closed laborat TE critical for calibration)	probability are given on the following pages ar ory facility: environment temperature (22 ± 3)* Cal Date (Certificate No.)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Power sensor E4412A	Interd in the closed laboration TE critical for calibration) ID # GB41293874 MY41495277 MY41498087	probability are given on the following pages ar ory facility: environment temperature (22 ± 3)* Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Apr-10
The measurements and the unor All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power sensor E44198 Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	ertainties with confidence inted in the closed laborat TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c)	probability are given on the following pages ar ory facility: environment temperature (22 ± 3)* Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01030)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Apr-10 Mar-10
The measurements and the unor All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power sensor E44128 Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator	ertainties with confidence inted in the closed laborat TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b)	probability are given on the following pages ar ory facility: environment temperature (22 ± 3)* Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Apr-10 Mar-10 Mar-10 Mar-10
The measurements and the union All calibrations have been condu- Calibration Equipment used (M8 Primary Standards Power sensor E44128 Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator	ertainties with confidence inted in the closed laborat TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b)	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01027)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10 Mar-10
The measurements and the unor All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter E44198 Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator	ertainties with confidence inted in the closed laborat TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b)	probability are given on the following pages ar ory facility: environment temperature (22 ± 3)* Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Apr-10 Mar-10 Mar-10 Mar-10
The measurements and the unor All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards	entainties with confidence inted in the closed laborat ITE entical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5056 (20b) SN: \$5129 (30b) SN: \$5129 (30b) SN: \$2328 SN: 769 ID #	cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01028)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10 Dec-09 Scheduled Check
The measurements and the unor All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6 DAE4	entainties with confidence inted in the closed laboration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5054 (3c) SN: S5129 (30b) SN: 2328 SN: 769	cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01028) 31-Oct-08 (No. 217-01027) 3-Oct-08 (No. DAE4-785_Oct09) 19-Oec-08 (No. DAE4-785_Dec08)	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Cet-10 Dec-09
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power sensor E44128 Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8763E	ertainties with confidence inted in the closed laborat TE critical for calibration) ID # GB41293874 MY41495277 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b) SN: S5129 (30b) SN: S5129 (30b) SN: S5129 (30b) SN: 2328 SN: 769 ID # US3642U01700 US37390585 Name	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Mar-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. 217-01028) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. 217-01027) 3-Oct-09 (No. 247-01027) 3-Oct-09 (No. 247-01027) 3-Oct-09 (No. 247-01027) 3-Oct-09 (No. 247-01027) 3-Oct-01 (in house) 4-Aug-99 (in base check Oct-09) 18-Oct-01 (in house check Oct-09) Function	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Oct-10 Dec-09 Scheduled Check In house check: Oct-11
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The measurements and the unor All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards RF generator HP 8648C	ertainties with confidence inted in the closed laborat TE critical for calibration) ID # GB41293874 MY41495277 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b) SN: S5129 (30b) SN: S5129 (30b) SN: S5129 (30b) SN: 2328 SN: 769 ID # US3642U01700 US37390585 Name	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Mar-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. 217-01028) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. 217-01027) 3-Oct-09 (No. 247-01027) 3-Oct-09 (No. 247-01027) 3-Oct-09 (No. 247-01027) 3-Oct-09 (No. 247-01027) 3-Oct-01 (in house) 4-Aug-99 (in base check Oct-09) 18-Oct-01 (in house check Oct-09) Function	nd are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Oct-10 Dec-09 Scheduled Check In house check: Oct-11 In house check: Oct-11

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



SWISS

S

- Schweizerischer Kalibrierdienst S
- Service suisse d'étalonnage C Servizio svizzero di taratura
 - Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization o	© rotation around probe axis
Polarization 9	9 rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., 9 = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz*, December 2005.

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f < 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). .
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW . signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset; The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ER3-2428 Oct09

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ER3DV6 SN:2428

October 20, 2009

Probe ER3DV6

SN:2428

Manufactured: Last calibrated: Recalibrated: September 11, 2007 December 13, 2007 October 20, 2009

Calibrated for DASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ER3-2428_Oct09

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ER3DV6 SN:2428

October 20, 2009

DASY - Parameters of Probe: ER3DV6 SN:2428

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k≡2)
Norm (µV/(V/m) ²)	1.52	1.59	1.86	± 10.1%
DCP (mV) ^A	91.5	93.0	98.9	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	с	VR mV	Unc (k=2)
10000	CW		х	0.00	0.00	1.00	300	± 1.5%
			Y	0.00	0.00	1.00	300	
			z	0.00	0.00	1.00	300	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

A numerical linearization parameter: uncertainty not required

Certificate No: ER3-2428_Oct09

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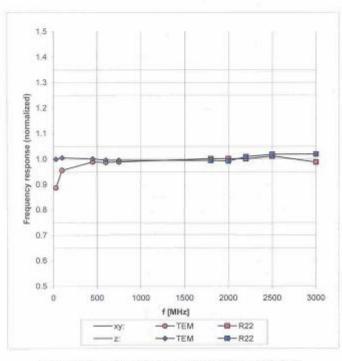
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ER3DV6 SN:2428

October 20, 2009

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

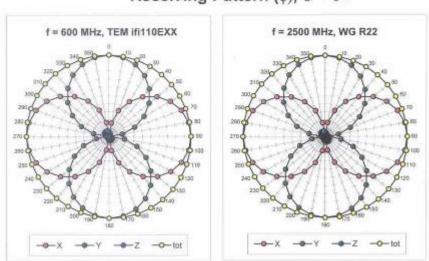
Certificate No: ER3-2428_Oct09

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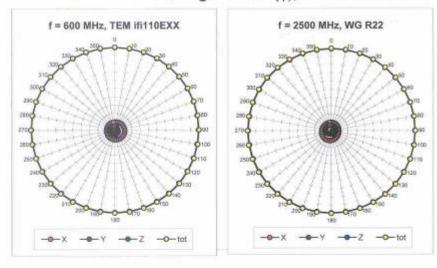
ER3DV6 SN:2428

October 20, 2009



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$

Receiving Pattern (ϕ), ϑ = 90°



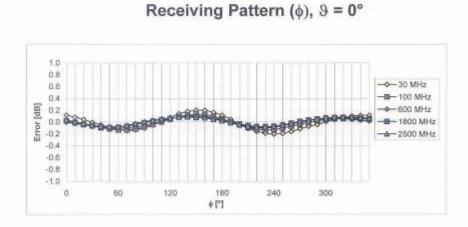
Certificate No: ER3-2428_Oct09

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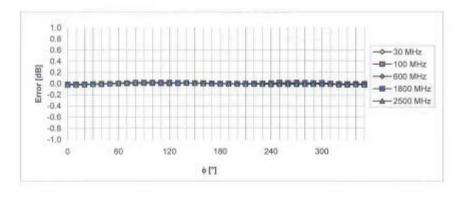
ER3DV6 SN:2428

October 20, 2009



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)





Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: ER3-2428_Oct09

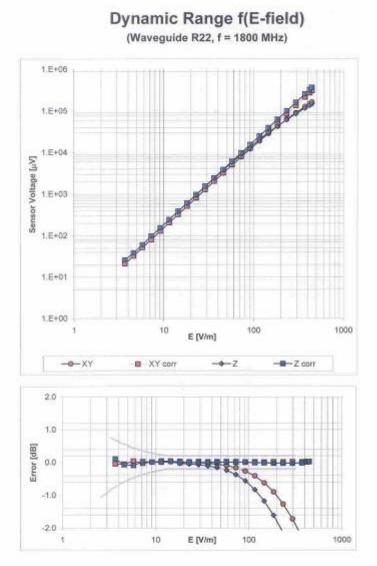
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ER3DV6 SN:2428

October 20, 2009



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ER3-2428_Oct09

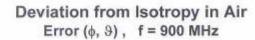
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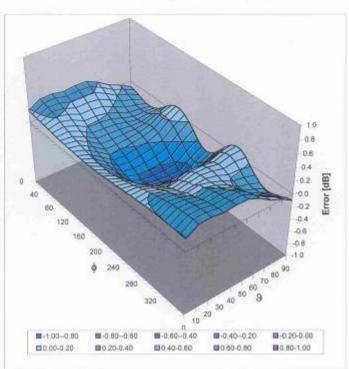
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ER3DV6 SN:2428

October 20, 2009





Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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ER3DV6 SN:2428

October 20, 2009

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-218.7
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8.0 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2428_Oct09

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ANNEX D: H-Probe Calibration Certificate

Schmid & Partner Engineering AG Jughausstrasse 43, 8004 Zurie	ry Of ch, Switzerland	HAC MRA	Service suisse d'étalonnage Servizio svizzero di taratura
Accredited by the Swiss Accredit The Swiss Accreditation Servic Multilateral Agreement for the (e is one of the signatori	es to the EA	1 No.: SCS 108
Client TMC			o: H3-6260_Oct09
CALIBRATION	CERTIFICAT	E	
Object	H3DV6 - SN:62	60	
Celibration procedure(s)	In the second of the second seco	and QA CAL-25.v2 edure for H-field probes optimized ir	for close near field
Calibration date:	October 20, 200	9	A service of the service of the
The measurements and the uno	ertainties with confidence	lional standards, which realize the physical un probability are given on the following pages an ory facility: environment temperature $(22 \pm 3)^{\circ}$	d are part of the certificate.
The measurements and the uno All calibrations have been condu	ertainties with confidence acted in the closed laborat		d are part of the certificate.
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8	ertainties with confidence acted in the closed laborat	probability are given on the following pages an ory facility: environment temperature $(22\pm3)^{\circ}t$	d are part of the certificate.
The measurements and the uno	ertainties with confidence acted in the closed laborat LTE critical for calibration)	probability are given on the following pages an	d are part of the certificate. C and humidity < 70%.
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards	ertainties with confidence acted in the closed laborat ATE critical for calibration)	probability are given on the following pages an ory facility: environment temperature (22 ± 3)°r Cal Date (Certificate No.)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration
The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter E4419B	ertainties with confidence acted in the closed laborat ATE critical for calibration) ID # GB41293874	probability are given on the following pages an ory facility: environment temperature (22 ± 3) ⁵ f Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	ertainties with confidence acted in the closed laborat kTE critical for calibration) ID # GB41293874 MY41495277 MY41495277 MY41498087 SN: S5054 (3c)	probability are given on the following pages an ory facility: environment temperature (22 ± 3)*(Cal Date (Certificate No.) 1-Apr-08 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01035)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power sensor E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY41495087 SN: S5054 (3c) SN: S5085 (20b)	probability are given on the following pages an ory facility: environment temperature (22 ± 3)*1 Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01030) 31-Mar-09 (No. 217-01025) 31-Mar-09 (No. 217-01028)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY41496087 SN: S5054 (3c) SN: S5085 (20b) SN: S5129 (30b)	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01027)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV8	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b) SN: 6182	Cal Date (Certificate No.) 1-Apr-08 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. H3-6182_Oct09)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10 Oct-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV8	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY41496087 SN: S5054 (3c) SN: S5085 (20b) SN: S5129 (30b)	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01027)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV8	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b) SN: 6182	Cal Date (Certificate No.) 1-Apr-08 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. H3-6182_Oct09)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10 Oct-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV8 DAE4	ertainties with confidence acted in the closed laborat LD # GB41293874 MY41495277 MY414950277 MY41498087 SN: S5086 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 5122 SN: 789	probability are given on the following pages an ory facility: environment temperature (22 ± 3)°(Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Octo9 (No. 217-01027) 3-Octo9 (No. 217-01027) 3-Octo8 (No. DAE4-789_Dec08)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10 Oct-10 Dec-09
The measurements and the uno All calibrations have been condu- Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 90 dB Attenuator Reference Probe H3DV8 DAE4 Secondary Standards	ertainties with confidence acted in the closed laborat ID # GB41293874 MY41495277 MY41495277 MY41498087 SN: S5054 (3c) SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b) SN: 6182 SN: 789 ID #	probability are given on the following pages an ory facility: environment temperature (22 ± 3)*(Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01025) 31-Mar-09 (No. 217-01025) 31-Mar-09 (No. 217-01027) 3-Oct-09 (No. 217-01027) 3-Oct-08 (No. DAE4-789_Dec08) Check Date (in house)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Mar-10 Dec-09 Scheduled Check
The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 7robe H3DV8 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY4149507 SN: S5054 (3c) SN: S5056 (20b) SN: S5056 (20b) SN: S5129 (30b) SN: S5129 (30b) SN: 6182 SN: 789 ID # US3642U01700 US37390585 Name	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-08 (No. DAE4-789_Dec08) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09) Function	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Oct-10 Dec-09 Scheduled Check In house check: Oct-11
The measurements and the uno All calibrations have been condu- Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV8 DAE4 Secondary Standards RF generator HP 8648C	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5085 (20b) SN: S5129 (30b) SN: S5129 (30b) SN: S6182 SN: 789 ID # US3642U01700 US37390585	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01025) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-08 (No. DAE4-789_Dec08) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Oct-10 Dec-09 Scheduled Check In house check: Oct-11 In house check: Oct-10
The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV8 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E	ertainties with confidence acted in the closed laborat STE critical for calibration) ID # GB41293874 MY41495277 MY4149507 SN: S5054 (3c) SN: S5056 (20b) SN: S5056 (20b) SN: S5129 (30b) SN: S5129 (30b) SN: 6182 SN: 789 ID # US3642U01700 US37390585 Name	Cal Date (Certificate No.) 1-Apr-09 (No. 217-01030) 31-Mar-09 (No. 217-01026) 31-Mar-09 (No. 217-01028) 31-Mar-09 (No. 217-01027) 3-Oct-08 (No. DAE4-789_Dec08) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09) Function	d are part of the certificate. C and humidity < 70%. Scheduled Calibration Apr-10 Apr-10 Mar-10 Mar-10 Mar-10 Oct-10 Dec-09 Scheduled Check In house check: Oct-11 In house check: Oct-10

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



- SWISS C Z Z C Z Z S
 - Schweizerischer Kalibrierdienst Service suisse d'étalonnage
 - Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

ter),
m

Calibration is Performed According to the Following Standards:

 a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X, Y,Z(I)_a0a1a2= X, Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X_a0a1a2 (no
 uncertainty required).

Certificate No: H3-6260_Oct09

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H3DV6 SN:6260

October 20, 2009

Probe H3DV6

SN:6260

Manufactured: Last calibrated: Recalibrated: September 7, 2007 December 13, 2007 October 20, 2009

Calibrated for DASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: H3-6260_Oct09

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Report No. RZA1109-1552HAC01

H3DV6 SN:6260

October 20, 2009

DASY - Parameters of Probe: H3DV6 SN:6260

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (A/m / √(μV))	0 2.47E-3	2.49E-3	2.95E-3	± 10.1%
Norm (A/m / √(μV))	1 -2.97E-5	5.62E-6	-4.47E-5	± 10.1%
Norm (A/m / v(µV))	2 4.84E-5	4.36E-5	6.01E-5	± 10.1%
DCP (mV) ^A	84.5	90.3	83.9	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	c	VR mV	Unc (k=2)
10000	CW	0.00	х	0.00	0.00	1.00	300	± 1.5%
			Y	0.00	0.00	1.00	300	
			z	0.00	0.00	1.00	300	_

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

¹ numerical linearization parameter: uncertainty not required

Certificate No: H3-6260_Oct09

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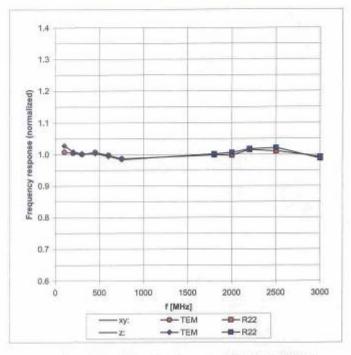
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H3DV6 SN:6260

October 20, 2009

Frequency Response of H-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of H-field: ± 6.3% (k=2)

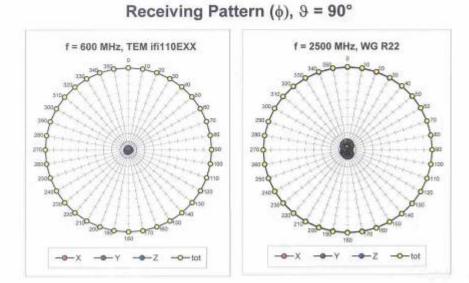
Certificate No: H3-6260_Oct09

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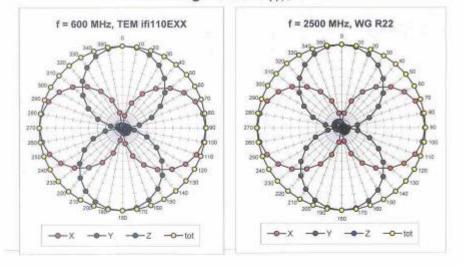
Report No. RZA1109-1552HAC01

H3DV6 SN:6260

October 20, 2009



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



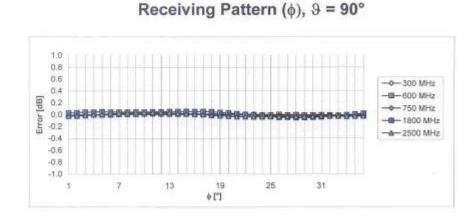
Certificate No: H3-6260_Oct09

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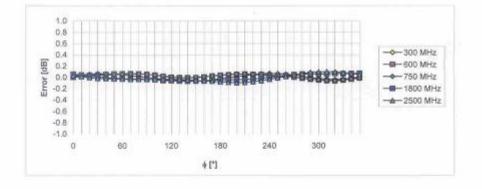
H3DV6 SN:6260

October 20, 2009



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: H3-6260_Oct09

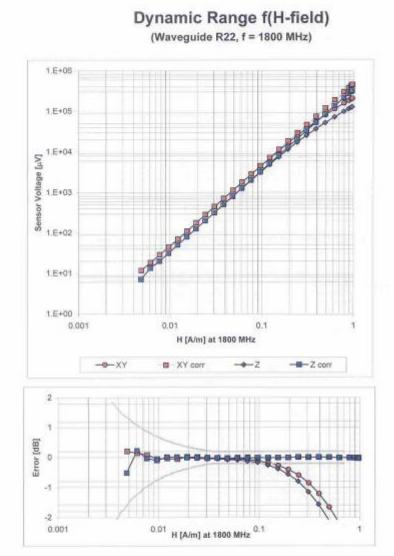
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H3DV6 SN:6260

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Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: H3-6260_Oct09

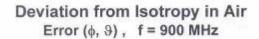
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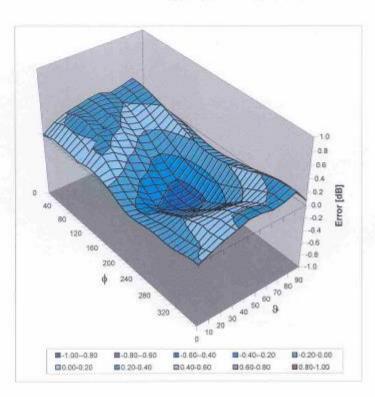
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Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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H3DV6 SN:6260

October 20, 2009

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (*)	-154.1
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	20 mm
Tip Diameter	6.0 mm
Probe Tip to Sensor X Calibration Point	3 mm
Probe Tip to Sensor Y Calibration Point	3 mm
Probe Tip to Sensor Z Calibration Point	3 mm

Certificate No: H3-5250_Oct09

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ANNEX E: CD835V3 Dipole Calibration Certificate

Engineering AG Zeughausstrasse 43, 8004 Zuri	ry of ch, Switzerland	Hac-MRA (PURS) S	Servizio svizzero di taratura
Accredited by the Swiss Accre The Swiss Accreditation Servi Multilateral Agreement for the	ce is one of the signate	ories to the EA	n No.: SCS 108
Client TA Technolog	ıy (Auden)	Cartificate N	o: CD835V3-1133_Apr09
CALIBRATION	CERTIFICA	TE	the state of the second
Object	CD835V3 - SN	4: 1133	
Calibration procedure(6)	QA CAL-20.v4 Calibration pro	cedure for dipoles in air	
Calibration date:	April 22, 2009		和確認知識的認識
Condition of the calibrated item	In Tolerance		和目前出现全部分的目标。
Provide Second Contraction of the William Contract of the Cont		atory facility: environment temperature (22 ± 3)*0	
			Scheduled Calibration
Primary Standards	TE critical for calibration	n) Csi Date (Certificate No.) 08-Oct-08 (No. 217-00898)	Scheduled Calibration
Primary Standards Power meter EPM-442A	ID#	Cal Date (Certificate No.)	1000000
Primary Standards Power meter EPM-442A Power sensor HP 8481A	ID # GB37480704	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898)	Oct-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6	ID # GB37480704 US37292783	Csl Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898)	Oct-09 Oct-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6	ID # GB37480704 US37292783 SN: 2336	Csl Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08)	Oct-09 Oct-09 Dec-09
Primery Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08) 20-Feb-09 (No. DAE4-781_Feb09)	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10
Primery Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	ID # GB37480704 US37292783 SN: 2336 SN: 6065	Csl Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08)	0ct-09 0ct-09 Dec-09 Dec-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter R&S NRP	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID #	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house)	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10 Scheduled Check
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter R&S NRP Power sensor R&S NRP-291	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-08 (in house check Dec-08)	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10 Scheduled Check
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter R&S NRP Power sensor R&S NRP-291 Power sensor R&S NRP-291 Network Analyzer HP 8753E	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748 SN: 100711	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Oec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-08 (in house check Dec-08) 25-Aug-08 (in house check Dec-08) 25-Aug-08 (in house check Dec-08) 18-Oct-01 (in house check Oct-08)	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10 Scheduled Check In house check: Dec-10 In house check: Dec-10 In house check: Dec-10 In house check: Oct-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter R&S NRP Power sensor R&S NRP-291 Power sensor R&S NRP-291 Network Analyzer HP 8753E	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748 SN: 100711 SN: 100712	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Oec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-08 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 25-Aug-06 (in house check Dec-08)	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10 Scheduled Check In house check: Dec-10 In house check: Dec-10 In house check: Dec-10
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter R&S NRP Power sensor R&S NRP-291 Power sensor R&S NRP-291 Network Analyzer HP 8753E	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748 SN: 100711 SN: 100712 US37390585	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Oec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-08 (in house check Dec-08) 25-Aug-08 (in house check Dec-08) 25-Aug-08 (in house check Dec-08) 18-Oct-01 (in house check Oct-08)	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10 Scheduled Check In house check: Dec-10 In house check: Dec-10 In house check: Dec-10 In house check: Oct-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power sensor R&S NRP Power sensor R&S NRP-291 Power sensor R&S NRP-291 Power sensor R&S NRP-291 Power sensor R&S NRP-291 Retwork Analyzer HP 8753E RF generator E4433B	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748 SN: 100711 SN: 100712 US37390565 MY 41310391	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-06 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 25-Aug-06 (in house check Oct-08) 25-Aug-06 (in house check Oct-08) 03-Nov-04 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Feb-10 Scheduled Check In house check: Dec-10 In house check: Dec-10 In house check: Dec-10 In house check: Oct-09 In house check: Oct-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe H3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter R&S NRP Power sensor R&S NRP-291 Power sensor R&S NRP-291 Power sensor R&S NRP-291 Network Analyzer HP 8753E RF generator E4433B Calibrated by:	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748 SN: 100711 SN: 100712 US37390585 MY 41310391	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-06 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 25-Aug-06 (in house check Oct-08) 25-Aug-06 (in house check Oct-08) 26-Out-01 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Feb-10 Scheduled Check In house check: Dec-10 In house check: Dec-10 In house check: Dec-10 In house check: Oct-09 In house check: Oct-09
Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power sensor R&S NRP-291 Power sensor R&S NRP-291 Power sensor R&S NRP-291 Network Analyzer HP 8753E RF generator E4433B Calibrated by: Approved by:	ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 101748 SN: 100711 SN: 100712 US37390585 MY 41310391 Name Mike Melli	Cal Date (Certificate No.) 08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Oec08) 20-Feb-09 (No. DAE4-781_Feb09) Check Date (in house) 23-Sep-08 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 25-Aug-06 (in house check Dec-08) 18-Oct-01 (in house check Dec-08) 18-Oct-01 (in house check Oct-07) Function Extension	Oct-09 Oct-09 Dec-09 Dec-09 Feb-10 Scheduled Check In house check: Dec-10 In house check: Dec-10 In house check: Dec-10 In house check: Oct-09 In house check: Oct-09

Certificate No: CD835V3-1133_Apr09

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Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

References [1] ANSI-

ANSI-C63.19-2006 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

[2] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

Certificate No: CD835V3-1133_Apr09

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B80
DASY PP Version	SEMCAD	V1.8 B186
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 180 mm
Frequency	835 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

condition	interpolated maximum
100 mW forward power	0.446 A/m

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end-	100 mW forward power	158.2 V/m
Maximum measured above low end	100 mW forward power	157.3 V/m
Averaged maximum above arm	100 mW forward power	157.8 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	18.2 dB	(43.3 – j12.9) Ohm
835 MHz	33.2 dB	(49.3 + j2.1) Ohm
900 MHz	17.4 dB	(53.5 - j13.6) Ohm
950 MHz	20.0 dB	(44.3 + j7.5) Ohm
960 MHz	14.8 dB	(53.2 + 18.8) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

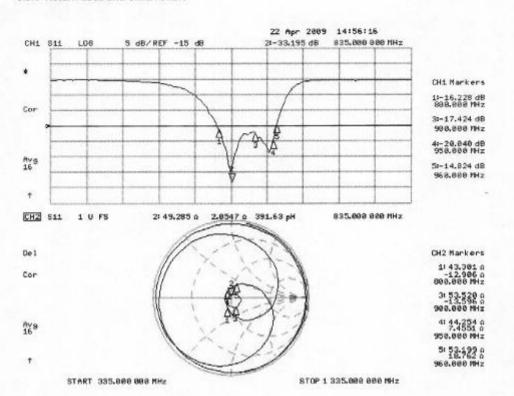
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3.3 Measurement Sheets



3.3.1 Return Loss and Smith Chart

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3.3.2 DASY4 H-field Result

Date/Time: 21.04.2009 13:38:21

Test Laboratory: SPEAG Lab 2

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1133 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $c_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

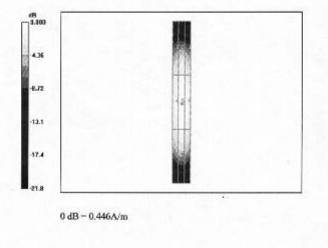
- Probe: H3DV6 SN6065; ; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.02.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.446 A/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, -6.30 mm Reference Value = 0.472 A/m; Power Drift = -0.006 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.364 M4	0.385 M4	0.368 M4
Grid 4	Grid 5	Grid 6
8.417 M4	0.446 M4	0.426 M4
Grid 7	Grid 8	Grid 9
0.365 M4	0.393 M4	0.376 M4



Certificate No: CD835V3-1133_Apr09

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Report No. RZA1109-1552HAC01

3.3.3 DASY4 E-field Result

Date/Time: 22.04.2009 12:51:53

Test Laboratory: SPEAG Lab 2

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1133 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY4 (High Precision Assessment)

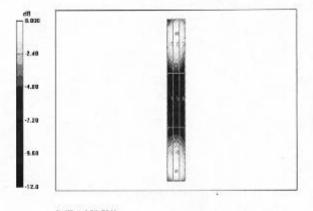
DASY4 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.02.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Ald Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 158.2 V/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, -6.30 mm Reference Value = 105.8 V/m; Power Drift = -0.013 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
152.4 M4	158.2 M4	154.6 M4
Grid 4	Grid 5	Grid 6
84.6 M4	86.9 M4	84.2 M4
Grid 7	Grid 8	Grid 9
151.7 M4	157.3 M4	152.4 M4



0 dB = 158.2V/m

Certificate No: CD835V3-1133_Apr09

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ANNEX F: CD1880V3 Dipole Calibration Certificate

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



GNISS C Z C Serv C Serv S Swis

S Schweizerischer Kalibrierdienst Service sulsse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client Auden

Certificate No: CD1880V3-1135_Jan10

Object	CD1880V3 - SN	: 1135	
Calibration procedure(s)	QA CAL-20.v5 Calibration proce	edure for dipoles in air	
Calibration date:	January 13, 201	0	
This calibration certificate docurr All calibrations have been condu Calibration Equipment used (M8	cted in the closed laborate	tional standards, which realize the physical un ony facility: environment temperature (22 \pm 3)°C	its of measurements (SI). 2 and humidity < 70%.
Primary Standards	10 *	Cal Date (Certilicate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01096)	Oct-10
Power sensor HP 8481A	US37292783	06-Oct-09 (No. 217-01086)	Oct-10
Probe ER3DV6	SN: 2336	30-Dec-09 (No. ER3-2336_Dec09)	Dec-10
Probe H3DV6	SN: 6065	30-Dec-09 (No. H3-6065_Dec09)	Dec-10
DAE4	SN: 781	30-Nov-09 (No. DAE4-781_Nov09)	Nov-10
Secondary Standards	D P	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-09)	In house check: Oct-10
Power sensor HP 8482H	SN: 3318A09450	09-Oct-09 (in house check Oct-09)	In house check: Oct-10
	SN: US37295597	09-Oct-09 (in house check Oct-09)	In house check: Oct-10
Power sensor HP 8482A	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct-10
Power sensor HP 8482A Network Analyzer HP 8753E	and a commenter	03-Nov-04 (in house check Oct-09)	In house check: Oct-11
	MY 41000675	DENDERA (INTIDES CIECS OCTOR)	
Network Analyzer HP 8753E	1 MY 41000675	Function	Signature
Network Analyzer HP 8753E			Signature
Network Analyzer HP 8753E RF generator E4433B	Name	Function.	Signature USL

Certificate No: CD1880V3-1135_Jan10

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Report No. RZA1109-1552HAC01

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Schweizerischer Kalibrierdienst

- Service suisse d'étalonnage
- Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2006

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

 ANSI-C63.19-2007 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe sensor offset. The vertical measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E- field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

Certificate No: CD1880V3-1135_Jan10

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1. Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2 B157
DASY PP Version	SEMCAD X	V14.0 B57
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2. Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.475 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW forward power	142.9 V/m
Maximum measured above low end	100 mW forward power	139.7 V/m
Averaged maximum above arm	100 mW forward power	141.3 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3. Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	18.8 dB	(47.5 + j10.9) Ohm
1880 MHz	21.2 dB	(51.5 + j8.7) Ohm
1900 MHz	21.8 dB	(54.4 + j7.3) Ohm
1950 MHz	26.4 dB	(54.9 - 1.1) Ohm
2000 MHz	20.0 dB	(41.0 - j0.8) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

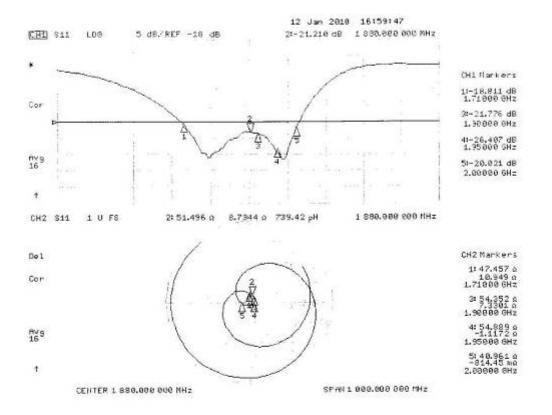
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



TA Technology (Shanghai) Co., Ltd. Test Report

3.3.2 DASY4 H-Field Result

Date/Time: 13.01.2010 12:17:00

Test Laboratory: SPEAG Lab2

 $\begin{array}{l} \label{eq:HAC_RF_CD1880_1135_100113_H_CL} \\ \mbox{DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1135} \\ \mbox{Communication System: CW; Frequency: 1880 MHz} \\ \mbox{Medium parameters used: $\sigma = 0$ mbo/m, $c_r = 1$; $\rho = 1$ kg/m^3$} \\ \mbox{Phantom section: RF Section} \\ \mbox{Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)} \\ \mbox{DASY5 Configuration:} \\ \mbox{Probe: H3DV6 - SN6065; ; Calibrated: 30.12.2009} \\ \end{array}$

- From: FSDV0 SN0005; Cambrates
 Sensor-Surface: (Fix Surface)
- Sensor-Surface: (Fix Surface)
 Electronics: DAE4 Su781: Calibrat
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
 Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Dipole H-Field measurement @ 1880MHz/H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.475 A/m Probe Modulation Factor = 1

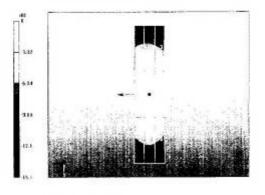
Device Reference Point: 0, 0, -6.3 num

Reference Value = 0.503 A/m; Power Drift = -0.017 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.421	0.436	0.410
M2	M2	M2
Grid 4	Grid 5	Grid 6
0.458	0.475	0.447
M2	M2	M2
Grid 7	Grid 8	Grid 9
0.412	0.431	0.407
M2	M2	M2



0 dB = 0.475A/m

TA Technology (Shanghai) Co., Ltd. Test Report

3.3.3 DASY4 E-Field Result

Date/Time: 13.01.2010 13:42:51

Test Laboratory: SPEAG Lab2

HAC_RF_CD1880_1135_100113_E_CL DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1135 Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ mho/m, $c_r = 1$: $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007) DASY5 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

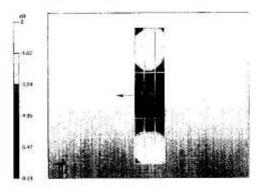
Dipole E-Field measurement @ 1880MHz/E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm. dy=5mm Maximum value of peak Total field = 142.9 V/m Probe Modulation Factor = 1 Device Reference Point: 0, 0, -6.3 mm Reference Value = 162.1 V/m; Power Drift = -0.010 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
136.2	139.7	135.5
M2	M2	M2
Grid 4	Grid 5	Grid 6
93.1	95.1	90.7
M3	M3	M3
Grid 7	Grid 8	Grid 9
135.2	142.9	140.6
M2	M2	M2



0 dB = 142.9V/m

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ANNEX G: DAE4 Calibration Certificate

Engineering AG aughausstrasse 43, 8004 Zurich	y Of h, Switzerland	Bac MRA	S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service
Accredited by the Swiss Accreditat The Swiss Accreditation Service Multilateral Agreement for the re	a is one of the signatories	to the EA	ditation No.: SCS 108
Client TA - SH (Aude	n)	Certifi	cate No: DAE4-871_Nov10
CALIBRATION C	ERTIFICATE		
Object	DAE4 - SD 000 D	04 BJ - SN: 871	
Calibration procedure(s)	QA CAL-06.v22 Calibration proces	dure for the data acquisition	n electronics (DAE)
Calibration date:	November 18, 20	10	NALINALISEUR (SEMISTRUM) ÂN
The measurements and the uncer	rtainties with confidence pro	nal standards, which realize the phy obability are given on the following p	ages and are part of the certificate.
The measurements and the uncer All calibrations have been conduc Calibration Equipment used (M&T	rtainties with confidence pro sted in the closed laboratory IE critical for calibration)	obability are given on the following p facility: environment temperature (2	ages and are part of the certificate. 2 ± 3)°C and humidity < 70%.
The measurements and the uncer All calibrations have been conduc Calibration Equipment used (M&T	rtainties with confidence pro	sbability are given on the following p	ages and are part of the certificate.
The measurements and the uncer All calibrations have been conduc Calibration Equipment used (M&T Primary Standards Keithley Multimeter Type 2001	rtainties with confidence pro sted in the closed laboratory I'E critical for calibration)	bability are given on the following p facility: environment temperature (2 Cal Date (Certificate No.) 28-Sep-10 (No:10376)	ages and are part of the certificate. 2 ± 3)°C and humidity < 70%. Scheduled Calibration
The measurements and the uncer All calibrations have been conduc Calibration Equipment used (M&T Primary Standards	rtainties with confidence pro sted in the closed laboratory IE critical for calibration) ID # SN: 0810278	bability are given on the following p facility: environment temperature (2 Cal Date (Certificate No.)	ages and are part of the certificate. 2 ± 3)°C and humidity < 70%. Scheduled Calibration Sep-11
The measurements and the uncer All calibrations have been conduct Calibration Equipment used (M&T Primary Standards Keithley Multimeter Type 2001 Secondary Standards	rtainties with confidence pro- sted in the closed laboratory IE critical for calibration) ID # SN: 0810278 ID # SE UMS 006 AB 1004	bability are given on the following p facility: environment temperature (2 <u>Cal Date (Certificate No.)</u> 28-Sep-10 (No:10376) <u>Check Date (in house)</u> 07-Jun-10 (in house check)	ages and are part of the certificate. (2 ± 3)°C and humidity < 70%. Scheduled Calibration Sep-11 Scheduled Check In house check: Jun-11
The measurements and the uncer All calibrations have been conduct Calibration Equipment used (M&T Primary Standards Keithley Multimeter Type 2001 Secondary Standards	rtainties with confidence pro sted in the closed laboratory IE critical for calibration) ID # SN: 0810278	bability are given on the following p facility: environment temperature (2 Cal Date (Certificate No.) 28-Sep-10 (No:10376) Check Date (in house)	ages and are part of the certificate. (2 ± 3)°C and humidity < 70%. Scheduled Calibration Sep-11 Scheduled Check
The measurements and the uncer All calibrations have been conduct Calibration Equipment used (M&T Primary Standards Keithley Multimeter Type 2001 Secondary Standards Calibrator Box V1.1	rtainties with confidence pro- sted in the closed laboratory IE critical for calibration) ID # SN: 0810278 ID # SE UMS 006 AB 1004	bability are given on the following p facility: environment temperature (2 <u>Cal Date (Certificate No.)</u> 28-Sep-10 (No:10376) <u>Check Date (in house)</u> 07-Jun-10 (in house check)	ages and are part of the certificate. (2 ± 3)°C and humidity < 70%. Scheduled Calibration Sep-11 Scheduled Check In house check: Jun-11

Certificate No: DAE4-871_Nov10

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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Glossary

DAE Connector angle data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a
 result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

 High Range:
 1LSB =
 6.1µV,
 full range =
 -100...+300 mV

 Low Range:
 1LSB =
 61nV,
 full range =
 -10....+3mV

 DASY measurement parameters: Auto Zero Time:
 3 sec; Measuring time:
 3 sec

Calibration Factors	X	Y	z
High Range	404.757 ± 0.1% (k=2)	404.740 ± 0.1% (k=2)	405.181 ± 0.1% (k=2)
Low Range	3.98219 ± 0.7% (k=2)	3.93489 ± 0.7% (k=2)	3.96831 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	90.0 ° ± 1 °
---	--------------

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Appendix

1. DC Voltage Linearity

High Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	200001.2	-1.56	-0.00
Channel X + Input	20000.71	0.71	0.00
Channel X - Input	-19997.87	1.63	-0.01
Channel Y + Input	199994.3	1.99	0.00
Channel Y + Input	19998.92	-1.08	-0.01
Channel Y - Input	-20000.26	-0.76	0.00
Channel Z + Input	200009.2	-1.04	-0.00
Channel Z + Input	19998.70	-1.10	-0.01
Channel Z - Input	-20000.16	-0.76	0.00

Low Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	2000.1	0.16	0.01
Channel X + Input	199.58	-0.52	-0.26
Channel X - Input	-200.79	-0.89	0.45
Channel Y + Input	1999.9	-0.03	-0.00
Channel Y + Input	199.45	-0.55	-0.27
Channel Y - Input	-200.31	-0.41	0.21
Channel Z + Input	2000.1	0.33	0.02
Channel Z + Input	199.13	-0.77	-0.38
Channel Z - Input	-201.47	-1.37	0.69

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (µV)
Channel X	200	14.25	12.86
	- 200	-12.68	-14.21
Channel Y	200	-10.04	-10.39
	- 200	9.20	9.17
Channel Z	200	-0.85	-1.40
	- 200	-0.34	-0.31

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200		2.85	0.69
Channel Y	200	2.41	-	2.73
Channel Z	200	2.54	0.73	12

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15920	15517
Channel Y	. 16171	16732
Channel Z	15803	16474

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (µV)	min. Offset (µV)	max. Offset (µV)	Std. Deviation (µV)
Channel X	0.03	-2.35	0.86	0.43
Channel Y	-0.50	-1.49	=0.49	0.38
Channel Z	-0.92	-2.21	0.14	0.44

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

ANNEX H: The EUT Appearances and Test Configuration



a: EUT



b: Battery Picture 1: Constituents of EUT

Report No. RZA1109-1552HAC01



Picture 2: Test Setup